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Application note

Document information

Information	Content
Keywords	K32W148, RF system, Bluetooth LE
Abstract	This document provides the RF evaluation test results of K32W148 EVK board for Bluetooth LE (2FSK modulation) and 802.15.4 (OQPSK modulation) applications.



1 Introduction

This document provides the RF evaluation test results of the K32W148 EVK board for Bluetooth LE (2FSK modulation) and 802.15.4 (OQPSK modulation) applications. It includes the test setup description and the tools used to perform the tests on your own. To get more K32W148 Bluetooth LE and 802.15.4 radio parameters, see the *K32W14x Data Sheet* (document K32W1480).

For more information about the K32W148-EVK, see the *K32W148-EVK Board User Manual* (document <u>K32W148-EVKUM</u>). Find the schematic and design files at <u>K32W148</u> page.





2 Software and list of equipment

Before measuring, load a binary code (connectivity software) into the flash memory of the board.

The <u>Secure and Ultra-Low-Power MCU for Matter over Thread</u> and <u>Bluetooth</u> <u>LE 5.3</u> webpage describes how to use K32W148-EVK to load the code for the Bluetooth LE or 802.15.4. The binary code used for the following tests is the Connectivity Software package for both Bluetooth LE and 802.15.4. For the explanation settings, see the K32W148 Connectivity Test for 802.15.4 Application (document <u>AN13687</u>) and the HCI_blackbox for Bluetooth LE only. The TERATERM terminal emulator is used to communicate with the K32W1 MCU.

2.1 List of equipment for Bluetooth

The equipment is used to perform the RX and TX measurements.

- 1. Spectrum analyzer: 25 GHz for harmonic measurements up to H10
- 2. R and S SFU, used as an interferer source for 802.15.4, could be any generator with ARB
- 3. MXG (Agilent N5182A)
- 4. R&S CMW270 (HCI_bbx software)
- 5. Agilent SML03
- 6. Agilent 33250A
- 7. R&S ZND vector network analyzer: for S11 measurements
- 8. RF Shielded box (to avoid interferers) and RF horn (for radiated measurements)
- 9. Power supply
- 10. PC equipped with a GPIB card

2.2 List of equipment for 802.15.4

- 1. R&S FSV: spectrum analyzer with 802.15.4 PHY test option
- 2. Keysight N5182B could be any generator with ARB
- 3. Keysight E8267D, used as an interferer source for 802.15.4, could be any generator with ARB
- 4. Spectrum analyzer: 25 GHz for harmonic measurements up to H10
- 5. R&S ZND vector network analyzer: for S11 measurements
- 6. Shielded room

Note: The K32W148 EVK VV21290023 is used to perform all 802.15.4 RF test measurements.

3 Bluetooth LE application

3.1 List of tests

Conducted tests

- TX tests
 - Bench setup
 - Frequency accuracy
 - Phase noise
 - TX power Bluetooth LE 1 Msps, 2 Msps, 500 ksps (LR S=2), 125 ksps (LR S=8)
 - TX power in-band
 - TX spurious (H2 to H10, ETSI, and FCC)
 - Lower band edge (MIIT-China)
 - Upper band edge
 - Maximum TX output power 1 Msps, 2 Msps, 500 ksps (LR S=2), 125 ksps (LR S=8)
 - Bluetooth LE TX output spectrum 1 Msps, 2 Msps
 - Modulation characteristics 1 Msps, 2 Msps, 125 ksps LR (S=8)
 - Carrier frequency offset and drift 1 Msps, 2 Msps, 125 ksps LR (S=8)
- RX tests
 - Bench setup
 - Sensitivity 1 Msps, 2 Msps, LR (S=2 and S=8)
 - Bathtub 1 Msps, 2 Msps, LR (S=2 and S=8)
 - Receiver maximum input level 1 Msps, 2 Msps, LR (S=2 and S=8)
 - RX spurious (from 30 MHz to 12.5 GHz)
 - Receiver interference rejection performances
 - Adjacent, Alternate, and Co channel rejection 1 Msps, 2 Msps, 500 ksps (LR S=2), 125 ksps (LR S=8)
 - Receiver blocking 1 Msps cat.1 and cat.2
 - Blocking interferers
 - Intermodulation

3.2 Test summary

RF PHY Bluetooth Test Specification: RF-PHY.TS.5.0.2 (2017-12-07)

The list of measurements is given in <u>Table 1</u> for Europe and <u>Table 2</u> for US.

Table 1. List of tests (Europe)

		Reference	Limit	Status
	TX maximum Output Power	Bluetooth LE 5.0, BV-01-C	-20 dBm ≤ PAVG ≤ +10 dBm EIRP	PASS
	TX power in-band – 1	Bluetooth LE 5.0,	$P_{TX} \le -20 \text{ dBm for } (f_{TX} +/- 2 \text{ MHz})$	PASS
	Msps	BV-03-C	P _{TX} <= -30 dBm for (f _{TX} +/- [3 + n] MHz]);	
	TX power in-band – 2	Bluetooth LE 5.0,	$P_{TX} \le$ -20 dBm for (f _{TX} +/- 4 MHz) and (f _{TX} +/- 5 MHz)	PASS
	Msps	BV-08-C	P _{TX} <= -30 dBm for (f _{TX} +/- [3 + n] MHz]);	
	Modulation characteristics 1 Msps LE coded (S=8)	Bluetooth LE 5.0, BV-05-C Bluetooth LE 5.0, BV-13-C	225 kHz <= delta f1avg <= 275 kHz	PASS
	Modulation characteristics 2 Msps	Bluetooth LE 5.0, BV-10-C	450 kHz <= delta f1avg <= 550 kHz	PASS
Transmission	Carrier frequency offset and drift 1 Msps	ncy t 1 Msps Bluetooth LE 5.0, BV-06-C Bluetooth LE 5.0, BV-06-C $f_{TX} - 150 \text{ kHz} <= \text{fn} <= \text{f}_{TX} + 150 \text{ kHz}$ where f_{TX} is the nominal transmit frequency and n = 0,1,2,3k f0 - fn <= 50 kHz where n=2,3,4k		PASS
	Carrier frequency offset and drift 2 Msps	Bluetooth LE 5.0, BV-12-C	f0 – f3 <= 19.2 kHz f0 – f(n-3) <= 19.2 kHz where n=7,8,9,…k	PASS
	Carrier frequency offset and drift LE coded (S=8)	Bluetooth LE 5.0, BV-14-C	$\label{eq:transmitting} \begin{array}{l} f_{TX} - 150 \mbox{ kHz} <= \mbox{fn} <= \mbox{f}_{TX} + \\ 150 \mbox{ kHz} \\ \mbox{where } f_{TX} \mbox{ is the nominal} \\ \mbox{transmit frequency and} \\ n=0,1,2,3k \\ \mbox{ f0 - fn } <= 50 \mbox{ kHz} \\ \mbox{where } n=2,3,4k \end{array}$	PASS
	Spurious 30 MHz - 1 GHz	ETSI EN 300 328 v2.2.1 (2019-04)	-36 dBm or -54 dBm (depends on frequency) (100 kHz BW)	PASS
	Spurious 1 GHz - 25 GHz	ETSI EN 300 328 v2.2.1 (2019-04)	-30 dBm (1 MHz BW)	PASS
	Eirp TX spectral density	ETSI EN 300 328 v2.2.1 (2019-04)	10 dBm/MHz	PASS
	Phase noise (unspread)	NA	NA	For information
Reception	RX sensitivity - 1 Msps	Bluetooth LE 5.0, BV-01-C	PER 30.8 % with a minimum of 1500 packets	PASS

Table 1. List of tests (Europe)...continued

	Reference	Limit	Status			
RX sensitivity - 2 Msps	Bluetooth LE 5.0, BV-08-C	PER 30.8 % with a minimum of 1500 packets	PASS			
RX sensitivity - LE coded (S=2)	Bluetooth LE 5.0, BV-26-C	PER 30.8 % with a minimum of 1500 packets	PASS			
RX sensitivity - LE coded (S=8)	Bluetooth LE 5.0, BV-27-C	PER 30.8 % with a minimum of 1500 packets	PASS			
Co-channel - 1 Msps	Bluetooth LE 5.0, BV-03-C	> 21 dB	PASS			
Co-channel - 2 Msps	Bluetooth LE 5.0, BV-09-C	> 21 dB	PASS			
Adjacent channel interference rejection (N+/-2,4,6+MHz) - 2 Msps	Bluetooth LE 5.0, BV-09-C	> 15 dB, -17 dB, -27 dB	PASS			
Co-channel - LE coded (S=2)	Bluetooth LE 5.0, BV-28-C	> 17 dB	PASS			
Adjacent channel interference rejection (N+/-2,4,6+ MHz) LE coded (S=2)	Bluetooth LE 5.0, BV-09-C	> 11 dB, -21 dB, -31 dB	PASS			
Co-channel - LE coded (S=8)	Bluetooth LE 5.0, BV-28-C	> 12 dB	PASS			
Adjacent channel interference rejection (N+/-2,4,6+ MHz) LE coded (S=8)	Bluetooth LE 5.0, BV-09-C	> 6 dB, -26 dB, -36 dB	PASS			
Blocking interferers						
1 Msps	Bluetooth LE 5.0, BV-04-C	-30 dBm (30 MHz-2 GHz and 3-12.5 GHz)	DASS			
2 Msps	Bluetooth LE 5.0, BV- 010-C	-35 dBm (2003-2399 MHz and 2484-2997 MHz)	FASS			
Intermodulation						
1 Msps	Bluetooth LE 5.0, BV-05-C	PER 30.8 % with a minimum	PASS			
2 Msps	Bluetooth LE 5.0, BV-11-C	of 1500 packets	1 400			
RX maximum input leve	1					
1 Msps	Bluetooth LE 5.0, BV-06-C	PER 30.8 % with a minimum	PASS			
2 Msps	Bluetooth LE 5.0, BV-12-C	of 1500 packets	.,			
RX emissions 30 MHz - 1 GHz	ETSI EN 300 328 v2.2.1 (2019-04)	-57 dBm (100 kHz)	PASS			

Table 1. List of tests (Europe)...continued

		Reference	Limit	Status
	RX emissions 1 GHz - 12.5 GHz	ETSI EN 300 328 v2.2.1 (2019-04)	-47 dBm (1 MHz)	PASS
Misc.	— Return loss (S11)	Return loss in TX mode	For information	
		Return loss in TX mode	For information	

Table 2. List of tests (US)

		Reference	Limit	Status
	TX maximum power	FCC part15.247	PAVG ≤ 100 mW +20 dBm EIRP	PASS
Transmission	Spurious 1 GHz - 25 GHz	FCC part15.249	field strength < 50 mV/m @3m -41.12 dBm (1 MHz BW)	PASS

3.3 Conducted tests

3.3.1 TX tests

3.3.1.1 Test setup





3.3.1.2 Frequency accuracy

Test method:

- Set the radio to:
 - TX mode
 - CW
 - Continuous mode
 - Frequency: Channel 19
- Set the analyzer to:
 - Center frequency = 2.44 GHz
 - Span = 1 MHz
 - Ref amp = 20 dBm
 - **–** RBW = 10 kHz
 - VBW = 100 kHz
- Measure the CW frequency with the marker of the spectrum analyzer.



- Measured frequency: 2.44004 GHz
- ppm value = (2.440020-2.440000)/2.440 = +0.8 ppm

Table 3. Frequency accuracy

Result	Target
+0.8 ppm	+/-25 ppm

The frequency accuracy depends on the XTAL model. The model used on EVK is NX2016SA EXS00A-CS14160 (NDK).

Conclusion:

• The frequency accuracy complies with the data sheet.

3.3.1.3 Phase noise

Test method:

- Set the radio to:
 - TX mode
 - CW
 - Continuous mode
 - Frequency: Channel 19
- Set the analyzer to:
 - Center frequency = 2.44 GHz
 - Span = 1 MHz
 - Ref amp = 20 dBm
 - **–** RBW = 10 kHz
 - VBW = 100 kHz
- Measure the CW frequency with the marker of the spectrum analyzer.
 - RBW (spectrum analyzer) = 10 kHz (20 log(10 kHz) = 40 dBc)

Result:

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• Marker value (delta) = -45.3 dBm/100 kHz = -95.3 dBc/Hz

Note: The phase noise is just for informational purposes. No specific issue on this parameter.

3.3.1.4 TX power (fundamental)

Test method:

- Set the radio to:
 - TX mode
 - Modulated
 - Continuous mode
 - Data rate: 1 Msps, 2 Msps, 500 ksps, 125 ksps for Bluetooth LE
- Set the analyzer to:
 - Start freq = 2.4 GHz
 - Stop freq = 2.5 GHz
 - Ref amp = 10 dBm
 - Sweep time = 100 ms
 - RBW = 3 MHz
 - **–** VBW = 3 MHz

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- Max Hold mode
- Detector = RMS
- Sweep all the channels from channel 0 to channel 39 for Bluetooth LE and channel.
- Software tools allow sweep from 2.36 GHz to 4.88 GHz





Figure 7. TX power

- Maximum power is on channel 0: 9.93 dBm
- Minimum power is on channel 15: 9.34 dBm
- Tilt over frequencies is: 0.6 dB

Conclusion:

- The default TX power is in line with the expected results.
- The power is flat over frequencies

3.3.1.5 TX power in-band

Test method:

- Set the radio to:
- TX mode, modulated, continuous mode, data rate (1 Msps, 2 Msps, 500 ksps, 125 ksps)
- · Set the analyzer to:
 - Start freq = 2.35 GHz, Stop freq = 2.5 GHz, Ref amp = 10 dBm, sweep time = 100 ms
 - RBW = 100 kHz, Video BW = 300 kHz
 - Max Hold mode
 - Detector = RMS
 - Number of Sweeps = 10
- Sweep on channel 2, channel 19, and channel 37

Result:



Figure 8. TX power in-band – Channel 2

Table 4. Bluetooth LE 1 Msps

Max peak level <=-2 MHz	-39.43	dBm	@	2.404	GHz
Max peak level >=+2 MHz	-38.84	dBm	@	2.408	GHz
Max peak level <=-3 MHz	-38.90	dBm	@	2.403	GHz
Max peak level >=+3 MHz	-39.62	dBm	@	2.411	GHz

Table 5. Bluetooth LE 2 Msps

Max peak level <=-2 MHz	-23.71	dBm	@	2.404	GHz
Max peak level >=+2 MHz	-24.88	dBm	@	2.408	GHz
Max peak level <=-3 MHz	-40.06	dBm	@	2.400	GHz
Max peak level >=+3 MHz	-40.27	dBm	@	2.412	GHz

Table 6. Bluetooth LE 500 ksps

Max peak level <=-2 MHz	-39.43	dBm	@	2.404	GHz
Max peak level >=+2 MHz	-38.84	dBm	@	2.408	GHz
Max peak level <=-3 MHz	-38.90	dBm	@	2.403	GHz
Max peak level >=+3 MHz	-39.62	dBm	@	2.411	GHz

Table 7. Bluetooth LE 125 ksps

Max peak level <=-2 MHz	-39.10	dBm	@	2.403	GHz
Max peak level >=+2 MHz	-37.76	dBm	@	2.408	GHz
Max peak level <=-3 MHz	-39.93	dBm	@	2.402	GHz
Max peak level >=+3 MHz	-39.35	dBm	@	2.410	GHz



Figure 9. TX power in-band – Channel 19

Table 8. Bluetooth LE 1 Msps

Max peak level <=-2 MHz	-39.43	dBm	@	2.437	GHz
Max peak level >=+2 MHz	-39.37	dBm	@	2.442	GHz
Max peak level <=-3 MHz	-40.22	dBm	@	2.436	GHz
Max peak level >=+3 MHz	-39.49	dBm	@	2.446	GHz

Table 9. Bluetooth LE 2 Msps

Max peak level <=-2 MHz	-24.58	dBm	@	2.438	GHz

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Table 9. Bluetooth LE 2 Msps...continued

Max peak level >=+2 MHz	-25.11	dBm	@	2.442	GHz
Max peak level <=-3 MHz	-39.18	dBm	@	2.437	GHz
Max peak level >=+3 MHz	-40.54	dBm	@	2.445	GHz

Table 10. Bluetooth LE 500 ksps

Max peak level <=-2 MHz	-39.43	dBm	@	2.437	GHz
Max peak level >=+2 MHz	-39.37	dBm	@	2.442	GHz
Max peak level <=-3 MHz	-40.22	dBm	@	2.436	GHz
Max peak level >=+3 MHz	-39.49	dBm	@	2.446	GHz

Table 11. Bluetooth LE 125 ksps

Max peak level <=-2 MHz	-38.04	dBm	@	2.438	GHz
Max peak level >=+2 MHz	-38.39	dBm	@	2.442	GHz
Max peak level <=-3 MHz	-39.60	dBm	@	2.434	GHz
Max peak level >=+3 MHz	-39.63	dBm	@	2.444	GHz



Figure 10. TX power in-band – Channel 37

Table 12. Bluetooth LE 1 Msps

Max peak level <=-2 MHz	-39.93	dBm	@	2.474	GHz
Max peak level >=+2 MHz	-39.75	dBm	@	2.478	GHz
Max peak level <=-3 MHz	-40.56	dBm	@	2.473	GHz
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Table 12. Bluetooth LE 1 Msps...continued

Max peak level >=+3 MHz -40.35 dBm @ 2.481 GHz						
	Max peak level >=+3 MHz	-40.35	dBm	@	2.481	GHz

Table 13. Bluetooth LE 2 Msps

Max peak level <=-2 MHz	-24.10	dBm	@	2.474	GHz
Max peak level >=+2 MHz	-24.69	dBm	@	2.478	GHz
Max peak level <=-3 MHz	-39.96	dBm	@	2.473	GHz
Max peak level >=+3 MHz	-40.21	dBm	@	2.480	GHz

Table 14. Bluetooth LE 500 ksps

Max peak level <=-2 MHz	-39.93	dBm	@	2.474	GHz
Max peak level >=+2 MHz	-39.75	dBm	@	2.478	GHz
Max peak level <=-3 MHz	-40.56	dBm	@	2.473	GHz
Max peak level >=+3 MHz	-40.35	dBm	@	2.481	GHz

Table 15. Bluetooth LE 125 ksps

Max peak level <=-2 MHz	-40.15	dBm	@	2.473	GHz
Max peak level >=+2 MHz	-38.53	dBm	@	2.478	GHz
Max peak level <=-3 MHz	-40.24	dBm	@	2.471	GHz
Max peak level >=+3 MHz	-40.15	dBm	@	2.480	GHz

Conclusion:

• These results are compliant to Bluetooth LE 5.0.

3.3.1.6 TX spurious

3.3.1.6.1 30 MHz to 25 GHz

Spurious overview of the full band from 30 MHz to 25 GHz when the device is in the transmission mode.



Figure 12. Bluetooth LE - Zoom In - Conducted TX spurious (30 MHz to 1 GHz)

Conclusion:

- There are no TX spurs above the EN 300 328 limit (more than 4 dB margin).
- Harmonics are measured in the following paragraphs.

3.3.1.6.2 H2 (ETSI test conditions, peak measurement)

Test method:

- Set the radio to:
 - TX mode
 - Modulated
 - Continuous mode
- · Set the analyzer to:
 - Start freq = 4.7 GHz
 - Stop freq = 5 GHz
 - Ref amp = -20 dBm
 - Sweep time = 100 ms
 - RBW = 1 MHz, VBW = 3 MHz
 - Max Hold mode
 - Detector: Peak
- Sweep all the channels from
 - Bluetooth LE: Channel 0 to Channel 39





Figure 13. Bluetooth LE - Conducted H2 spurious

• Maximum power is at frequency 4.748 GHz: -41.86 dBm.

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Conclusion:

• There is more than **11 dB** margin for Bluetooth LE to the ETSI limit.

3.3.1.6.3 H3 (ETSI test conditions, peak measurement)

Test method:

The same method as for H2, except that the spectrum analyzer frequency start/stop is set to 7.0 GHz and 7.5 GHz.

Result:



Figure 14. Bluetooth LE - Conducted H3 spurious

• Maximum power is at frequency 7.098 GHz: -53.67 dBm.

Conclusion:

• There is more than **23 dB** margin for Bluetooth LE to the ETSI limit.

3.3.1.6.4 H4 (ETSI test conditions, peak measurement)

Test method:

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The same method as for H2, except that the spectrum analyzer frequency span is set from 9.4 GHz to 10.0 GHz.

Result:



Figure 15. Bluetooth LE - Conducted H4 spurious

• Maximum power is at frequency 9.82 GHz: -49.66 dBm.

Conclusion:

• There is more than **19 dB** margin for Bluetooth LE to the ETSI limit.

3.3.1.6.5 H5 (ETSI test conditions, peak measurement)

Test method:

The same method as for H2, except that the spectrum analyzer frequency span is set from 11.7 GHz to 12.5 GHz.





• Maximum power is at frequency 12.0275 GHz: -53.17 dBm.

Conclusion:

• There is more than **23 dB** margin for Bluetooth LE to the ETSI limit.

3.3.1.6.6 H6 (ETSI test conditions, peak measurement)

Test method:

The same method as for H2, except that the spectrum analyzer frequency span is set from 14.1 GHz to 15 GHz. **Result:**





Figure 17. Bluetooth LE - Conducted H6 spurious

• Maximum power is at frequency 14.9118 GHz: -43.11 dBm.

Conclusion:

• There is more than **13 dB** margin for Bluetooth LE to the ETSI limit.

3.3.1.6.7 H7 (ETSI test conditions, peak measurement)

Test method:

The same method as for H2, except that the spectrum analyzer frequency span is set from 16.45 GHz to 17.5 GHz.



Figure 18. Bluetooth LE - Conducted H7 spurious

• Maximum power is at frequency 17.1199 GHz: -42.65 dBm.

Conclusion:

• There is more than **12 dB** margin for Bluetooth LE to the ETSI limit.

3.3.1.6.8 H8 (ETSI test conditions, peak measurement)

Test method:

The same method as for H2, except that the spectrum analyzer frequency span is set from 16.45 GHz to 17.5 GHz.



Figure 19. Bluetooth LE - Conducted H8 spurious

• Maximum power is at frequency 19.6328 GHz: -41.82 dBm.

Conclusion:

• There is more than **11 dB** margin for Bluetooth LE to the ETSI limit.

3.3.1.6.9 H9 (ETSI test conditions, peak measurement)

Test method:

The same method as for H2, except that the spectrum analyzer frequency span is set from 21.15 GHz to 22.5 GHz.





Figure 20. Bluetooth LE - Conducted H9 spurious

• Maximum power is at frequency 21.6819 GHz: -37.1 dBm.

Conclusion:

• There is more than **7 dB** margin for Bluetooth LE to the ETSI limit.

3.3.1.6.10 H10 (ETSI test conditions, peak measurement)

Test method:

The same method as for H2, except that the spectrum analyzer frequency span is set from 23.35 GHz to 25 GHz.



Figure 21. Bluetooth LE - Conducted H10 spurious

• Maximum power is at frequency 24.739 GHz: -36.23 dBm.

Conclusion:

• There is more than 6 dB margin for Bluetooth LE to the ETSI limit.

3.3.1.6.11 H2 (FCC test conditions, average measurements)

Test method:

- Set the radio to:
 - TX mode
 - Modulated
 - Continuous mode
- Set the analyzer to:
 - Start freq = 4.7 GHz
 - Stop freq = 5 GHz
 - Ref amp = -20 dBm
 - Sweep time = 100 ms
 - **–** RBW = 1 MHz
 - **–** VBW = 3 MHz

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- Max Hold mode
- Detector: RMS
- Sweep all the channels from
 - Bluetooth LE: Channel 0 to Channel 39

Result:



• Maximum power is at frequency 4.906 GHz: -42.14 dBm.

Conclusion:

• There is more than **1 dB** margin for Bluetooth LE to the FCC limit.

3.3.1.6.12 H3 (FCC test conditions, average measurements)

Test method:

The same method as for H2, except that the spectrum analyzer frequency span is set from 7.0 GHz to 7.5 GHz. **Result:**



• Maximum power is at frequency 7.354 GHz: -54.27 dBm.

Conclusion:

• There is more than **13 dB** margin for Bluetooth LE to the FCC limit.

3.3.1.6.13 H4 (FCC test conditions, average measurements)

Test method:

The same method as for H2, except that the spectrum analyzer frequency span is set from 9.4 GHz to 10 GHz. **Result:**



Maximum power is at frequency 9.939 GHz: -54.09 dBm.

Conclusion:

• There is more than **5 dB** margin for Bluetooth LE to the FCC limit.

3.3.1.6.14 H5 (FCC test conditions, average measurements)

Test method:

The same method as for H2, except that the spectrum analyzer frequency span is set from 11.7 GHz to 12.5 GHz.



• Maximum power is at frequency 12.081 GHz: -54.59 dBm.

Conclusion:

• There is more than **13 dB** margin for Bluetooth LE to the FCC limit.

3.3.1.6.15 H6 (FCC test conditions, average measurements)

Test method:

The same method as for H2, except that the spectrum analyzer frequency span is set from 14.1 GHz to 15 GHz. **Result:**





Figure 26. Bluetooth LE - Conducted H6 FCC spurious

• Maximum power is at frequency 14.972 GHz: -45.11 dBm.

Conclusion:

• There is more than 4 dB margin to the FCC limit.

3.3.1.6.16 H7 (FCC test conditions, average measurements)

Test method:

The same method as for H2, except that the spectrum analyzer frequency span is set from 16.45 GHz to 17.5 GHz.



Figure 27. Bluetooth LE - Conducted H7 FCC spurious

• Maximum power is at frequency 16.888 GHz: -45.02 dBm.

Conclusion:

• There is more than **4 dB** margin to the FCC limit.

3.3.1.6.17 H8 (FCC test conditions, average measurements)

Test method:

The same method as for H2, except that the spectrum analyzer frequency span is set from 16.45 GHz to 17.5 GHz.



Figure 28. Bluetooth LE - Conducted H8 FCC spurious

• Maximum power is at frequency 19.511 GHz: -44.44 dBm.

Conclusion:

• There is more than **3 dB** margin to the FCC limit.

3.3.1.6.18 H9 (FCC test conditions, average measurements)

Test method:

The same method as for H2, except that the spectrum analyzer frequency span is set from 21.15 GHz to 22.5 GHz.



• Maximum power is at frequency 21.256 GHz: -41.22 dBm.

Conclusion:

• There is no margin (~0.2 dB) to the FCC limit.

3.3.1.6.19 H10 (FCC test conditions, average measurements)

Test method:

The same method as for H2, except that the spectrum analyzer frequency span is set from 23.35 GHz to 25 GHz.



Figure 30. Bluetooth LE - Conducted H10 FCC spurious

• Maximum power is at frequency 24.350 GHz: -41.13 dBm.

Conclusion:

• There is no margin (~0.1 dB) to the FCC limit.

3.3.1.7 Lower band edge – MIIT China

Test method:

- Set the radio to:
 - TX mode
 - Modulated
 - Burst mode
 - Set the channel 0 (2.402 GHz)
- Set the analyzer to:
 - Start freq = 2.375 GHz
 - Stop freq = 2.405 GHz
 - Ref amp = -20 dBm
 - Sweep time = 100 ms
 - Sweep point: 8001 pts
 - **–** RBW = 1 MHz
 - Video BW = 3 MHz
 - Detector = RMS
 - MaxHold
- Software settings:
 - PA_RAMP_SEL value must be set to 0x02h (2 µs)

- Modification: XCVR_TX_DIG_PA_CTRL_PA_RAMP_SEL(2) in the nxp_xcvr_common_config.c file

Bluetooth LE result:





Conclusion:

- The lower band edge test passes the Bluetooth SIG (MIIT-China) certification.
- There is no margin to the Bluetooth SIG (MIIT-China) limit (-40 dBm below 2.39 GHz).

3.3.1.8 Upper band edge – MIIT China

Test method:

- Set the radio to:
 - TX mode
 - Modulated
 - Burst mode
 - Set the channel 39 (2.48 GHz)
 - Set the power to 3 (-12 dBm) for Bluetooth LE
- · Set the analyzer to:
 - Start freq = 2.477 GHz

- Stop freq = 2.507 GHz
- Ref amp = -20 dBm
- Sweep time = 40 ms
- Sweep point: 8001 pts
- RBW = 1 MHz
- Video BW = 3 MHz
- Detector = RMS
- MaxHold
- · Software settings:
 - PA_RAMP_SEL value must be set to <code>0x03h</code> (4 μs)
 - Modification: XCVR_TX_DIG_PA_CTRL_PA_RAMP_SEL(2) in the nxp_xcvr_common_config.c file

Bluetooth LE result:



Conclusion:

- The upper band edge test passes the Bluetooth SIG (MIIT-China) certification.
- There is no margin to the Bluetooth SIG (MIIT-China) limit (-40 dBm higher than 2.4835 GHz).

3.3.1.9 Upper band edge (FCC ANSI C63.10, 558074 D01 DTS)

Test method:

- Set the radio to:
 - TX mode
 - Modulated (1 Msps, 2 Msps, 500 ksps, 125 ksps)
 - Continuous mode
- Maximum RF output power +10 dBm
- · Set the analyzer to:
 - Start freq = 2.475 GHz
- Stop freq = 2.485 GHz
- Ref amp = -20 dBm
- Sweep time = 100 ms
- **–** RBW = 100 kHz
- Video BW = 300 kHz
- Detector = Average
- Average mode: Power
- Number of Sweeps = 100
- Set the channel 39 (2.48 GHz)
- Trace mode: Max hold

Bluetooth LE result:



Modulation	1 Msps	2 Msps	500 ksps	125 ksps
Level @2.4835 GHz	-45.09 dBm	-44.45 dBm	-43.59 dBm	-44.31 dBm

FCC limit: -41.15 dBm

Conclusion:

- The upper band edge test passes the FCC certification (< 41.15 dBm@2.4835 GHz).
- There is a minimum of 2 dB margin.

3.3.1.10 Out of band (ETSI 300 328 chapter 5.4.8.2.1)

Test method:

- Set the radio to:
 - TX mode
 - Modulated
 - Continuous mode
- · Set the analyzer to:
 - Start freq = 2.475 GHz
 - Stop freq = 2.485 GHz
 - Ref amp = -20 dBm
 - Sweep time = 100 ms
 - **–** RBW = 1 MHz
 - Video BW = 3 MHz
 - Detector = RMS
 - Average mode: Power
 - Number of Sweeps = 100
 - Set the channel 39 (2.48 GHz)
 - Trace mode: Max hold

Bluetooth LE result:





Conclusion:

- The upper band edge test passes the FCC certification (< 41.15 dBm@2.4835 GHz).
- There is no margin by setting the RF output power to +0 dBm to the FCC limit.
- Decrease the RF output level to the channel 0 to fix your margin.

3.3.1.11 Out of band (ARIB STD T-66)

Test method:

- Set the radio to:
 - TX mode
 - Modulated
 - Continuous mode
- · Set the analyzer to:
 - Start freq = 2.475 GHz
 - Stop freq = 2.485 GHz
 - Ref amp = -20 dBm
 - Sweep time = 100 ms
 - RBW = 1 MHz
 - Video BW = 3 MHz
 - Detector = RMS

- Average mode: Power
- Number of Sweeps = 100
- Set the channel 39 (2.48 GHz), Trace mode: Max hold

Summary results:

Table 16. Result for Channel 0

Frequen	cy band		Limit			
Data	Data rate 1 Mbps 2 Mbps LR S2 LR S8				LR S8	Linit
	Band I					-36 dBm/100 kHz
	(dBm/100 kHz)					(0.25 uW/100 kHz)
	Band II					-26 dBm/MHz
1 los	(dBm/MHz)					(2.5 uW/MHz)
Emission	Band III					-16 dBm/MHz
Intensity	(dBm/MHz)					(25 uW/MHz)
	Band IV					-16 dBm/MHz
	(dBm/MHz)					(25 uW/MHz)
	Band V					-26 dBm/MHz
	(dBm/MHz)					(2.5 uW/MHz)

Table 17. Result for Channel 39

Frequency band			Limit			
Data	rate	1 Mbps	2 Mbps	LR S2	LR S8	Linit
	Band I					-36 dBm/100kHz
	(dBm/100 kHz)					(0.25 uW/100kHz)
	Band II					-26 dBm/MHz
	(dBm/MHz)					(2.5 uW/MHz)
Emission	Band III					-16 dBm/MHz
Intensity	(dBm/MHz)					(25 uW/MHz)
	Band IV					-16 dBm/MHz
	(dBm/MHz)					(25 uW/MHz)
	Band V					-26 dBm/MHz
	(dBm/MHz)					(2.5 uW/MHz)

- Band I: 30 MHz 1000 MHz
- Band II: 1000 MHz 2387 MHz
- Band III: 2387 MHz 2400 MHz
- Band IV: 2483.5 MHz 2496.5 MHz
- Band V: 2496.5 MHz 12500 MHz

Detailed results:



Conclusion:

- The out of band test passes the ARIB STD T-66 certification.
- There is no margin by setting the RF output power to +0 dBm to the FCC limit.

3.3.1.12 Maximum TX output power

A CMW equipment is used to measure the PER at the maximum TX output power.

Flashed software: A specific binary is flashed: hci_bb.bin (available in the Bluetooth application examples).

Test method:

- Generator for the desired signal: CMW R&S
- Criterion: PER < 30.8 % with 1500 packets
- Channels under test: 0, 19, and 39

Result:

Table 18. Bluetooth LE 1 Msps

TP/TRM-LE/CA/BV-01-C [Output power at 1 Ms/s]	Lower limit	Upper limit	Measured	Unit	Status				
TP/TRM-LE/CA/BV-01-C [Output power at 1 Ms/s] @ Payload length: 37, Statistic Count: 1									
Channel 0									
Average Power	-20.0	20.0	10.72	dBm	Passed				
Peak Power	-	13.72	11.13	dBm	Passed				
Channel 19									
Average Power	-20.0	20.0	10.58	dBm	Passed				
Peak Power	-	13.58	11.01	dBm	Passed				
Channel 39									
Average Power	-20.0	20.0	10.35	dBm	Passed				
Peak Power	-	13.35	10.77	dBm	Passed				

Conclusion:

In line with the expected results.

3.3.1.13 Bluetooth LE TX output spectrum

A CMW equipment is used to measure the adjacent channel power.

Flashed software: A specific binary is flashed: hci_bb.bin (available in the Bluetooth application examples)

Test method:

- Generator for the desired signal: CMW R&S
- Criterion: PER < 30.8 % with 1500 packets
- Channels under test: 3, 19 and 37

Result:





Figure 40. Channel 2, 2 Msps



3.3.1.14 Modulation characteristics

A CMW equipment is used to measure the frequency deviation df1 and df2.

Flashed software: A specific binary is flashed: hci_bb.bin (available in the Bluetooth application examples). All information provided in this document is subject to legal disclaimers.

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Test method:

- Generator for the desired signal: CMW R&S
- Criterion: PER < 30.8 % with 1500 packets
- Channels under test: 0, 19, and 39

Result:

 Table 19. Modulation characteristics at 1 Msps

TP/TRM-LE/CA/BV-05-C [Modulation Characteristics at 1 Ms/s]	Lower limit	Upper limit	Measured	Unit	Status
TP/TRM-LE/CA/BV-05-C [Modulation Cha	racteristics at 1 M	/Is/s] @ Payload	length: 37, Statis	tic Cour	nt: 10
Channel 0					
Frequency Deviation df1 Average	225	275	250.10	kHz	Passed
Frequency Deviation df2 99.9 %	185	_	204.84	kHz	Passed
Frequency Deviation df2 Average/df1 Average	0.80	_	0.84	-	Passed
Channel 19					
Frequency Deviation df1 Average	225	275	256.61	kHz	Passed
Frequency Deviation df2 99.9 %	185	_	209.14	kHz	Passed
Frequency Deviation df2 Average/df1 Average	0.80	_	0.84	-	Passed
Channel 39					
Frequency Deviation df1 Average	225	275	250.52	kHz	Passed
Frequency Deviation df2 99.9 %	185	_	210.94	kHz	Passed
Frequency Deviation df2 Average/df1 Average	0.80	_	0.86	-	Passed

Table 20. Modulation characteristics at 2 Msps

TP/TRM-LE/CA/BV-05-C [Modulation Characteristics at 2 Ms/s]	Lower limit	Upper limit	Measured	Unit	Status				
TP/TRM-LE/CA/BV-10-C [Modulation Characteristics at 2 Ms/s] @ Payload length: 37, Statistic Count: 10									
Channel 0									
tblContinuation_7_1									
Frequency Deviation df1 Average	450	550	506.34	kHz	Passed				
tblContinuation_7_2									
Frequency Deviation df2 99.9 %	370	_	400.70	kHz	Passed				
Frequency Deviation df2 Average/df1 Average	0.80	-	0.81	-	Passed				
Channel 19									
tblContinuation_7_3									
Frequency Deviation df1 Average	450	550	500.85	kHz	Passed				
tblContinuation_7_4									

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Table 20. Modulation characteristics at 2 Mspscontinued							
TP/TRM-LE/CA/BV-05-C [Modulation Characteristics at 2 Ms/s]	Lower limit	Upper limit	Measured	Unit	Status		
TP/TRM-LE/CA/BV-10-C [Modulation Cha	racteristics at 2 M	/Is/s] @ Payload	length: 37, Statis	tic Cour	nt: 10		
Frequency Deviation df2 99.9 %	370	-	402.89	kHz	Passed		
Frequency Deviation df2 Average/df1 Average	0.80	_	0.83	_	Passed		
Channel 39							
tblContinuation_7_5							
Frequency Deviation df1 Average	450	550	505.42	kHz	Passed		
tblContinuation_7_6							
Frequency Deviation df2 99.9 %	370	-	402.30	kHz	Passed		
Frequency Deviation df2 Average/df1 Average	0.80	_	0.82	_	Passed		

Table 21. Modulation characteristics at LE coded (S8)

TP/TRM-LE/CA/BV-13-C [Modulation Characteristics, LE Coded (S = 8)]	Lower limit	Upper limit	Measured	Unit	Status		
TP/TRM-LE/CA/BV-13-C [Modulation Cha	racteristics, LE C	oded (S = 8)] @	Payload length: 3	87, Statis	stic Count: 10		
Channel 0							
tblContinuation_9_1							
Frequency Deviation df1 Average	225	275	252.43	kHz	Passed		
tblContinuation_9_2							
Frequency Deviation df1 99.9 %	185	_	242.22	kHz	Passed		
Channel 19							
tblContinuation_9_3							
Frequency Deviation df1 Average	225	275	250.74	kHz	Passed		
Frequency Deviation df1 99.9 %	185	_	241.82	kHz	Passed		
Channel 39							
tblContinuation_9_4							
Frequency Deviation df1 Average	225	275	251.84	kHz	Passed		
Frequency Deviation df1 99.9 %	185	_	241.22	kHz	Passed		

Conclusion:

Good margins, in line with the expected results.

3.3.1.15 Carrier frequency offset and drift

A CMW equipment is used to measure the frequency deviation df1 and df2.

Flashed software: A specific binary is flashed: hci bb.bin (available in the Bluetooth application examples). Test method:

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- Generator for the desired signal: CMW R&S
- Criterion: PER < 30.8 % with 1500 packets
- Channels under test: 0, 19, and 39

Result:

Table 22. Carrier frequency offset and drift at 1 Msps

TP/TRM-LE/CA/BV-06-C [Carrier frequency offset and drift at 1 Ms/s]	Lower limit	Upper limit	Measured	Unit	Status				
TP/TRM-LE/CA/BV-06-C [Carrier frequency offset and drift at 1 Ms/s] @ Payload length: 37, Statistic Count: 10									
Channel 0									
Frequency Accuracy	-150.00	150.00	7.31	kHz	Passed				
Frequency Drift	-50.00	50.00	3.32	kHz	Passed				
Maximum Drift Rate	-20.00	20.00	1.43	kHz/50 μs	Passed				
Frequency Offset	-150.00	150.00	8.82	kHz	Passed				
Initial Frequency Drift	-23.00	23.00	2.20	kHz	Passed				
Channel 19									
Frequency Accuracy	-150.00	150.00	8.22	kHz	Passed				
Frequency Drift	-50.00	50.00	1.96	kHz	Passed				
Maximum Drift Rate	-20.00	20.00	1.44	kHz/50 µs	Passed				
Channel 39									
Frequency Accuracy	-150.00	150.00	7.87	kHz	Passed				
Frequency Drift	-50.00	50.00	2.06	kHz	Passed				
Maximum Drift Rate	-20.00	20.00	1.47	kHz/50 µs	Passed				
Frequency Offset	-150.00	150.00	9.19	kHz	Passed				
Initial Frequency Drift	-23.00	23.00	1.70	kHz	Passed				

Table 23. Carrier frequency offset and drift at 2 Msps

TP/TRM-LE/CA/BV-12-C [Carrier frequency offset and drift at 2 Ms/s]	Lower limit	Upper limit	Measured	Unit	Status					
TP/TRM-LE/CA/BV-12-C [Carrier frequence	TP/TRM-LE/CA/BV-12-C [Carrier frequency offset and drift at 2 Ms/s] @ Payload length: 37, Statistic Count: 10									
Channel 0										
tblContinuation_8_1										
Frequency Accuracy	-150.00	150.00	-24.33	kHz	Passed					
Frequency Drift	-50.00	50.00	-4.54	kHz	Passed					
Maximum Drift Rate	-20.00	20.00	-2.25	kHz/50 μs	Passed					
Frequency Offset	-150.00	150.00	-27.50	kHz	Passed					
Initial Frequency Drift	-23.00	23.00	-2.49	kHz	Passed					

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TP/TRM-LE/CA/BV-12-C [Carrier frequency offset and drift at 2 Ms/s]	Lower limit	Upper limit	Measured	Unit	Status
TP/TRM-LE/CA/BV-12-C [Carrier frequence	y offset and drift	at 2 Ms/s] @ Pa	yload length: 37,	Statistic	Count: 10
Channel 19					
tblContinuation_8_2					
Frequency Accuracy	-150.00	150.00	-24.48	kHz	Passed
Frequency Drift	-50.00	50.00	-5.12	kHz	Passed
Maximum Drift Rate	-20.00	20.00	-2.69	kHz/50 μs	Passed
Frequency Offset	-150.00	150.00	-27.86	kHz	Passed
Initial Frequency Drift	-23.00	23.00	-2.69	kHz	Passed
Channel 39					
tblContinuation_8_3					
Frequency Accuracy	-150.00	150.00	-24.91	kHz	Passed
Frequency Drift	-50.00	50.00	-5.47	kHz	Passed
Maximum Drift Rate	-20.00	20.00	-1.91	kHz/50 µs	Passed
Frequency Offset	-150.00	150.00	-28.63	kHz	Passed
Initial Frequency Drift	-23.00	23.00	-2.73	kHz	Passed

Table 23. Carrier frequency offset and drift at 2 Msps...continued

Table 24. Carrier frequency offset and drift at LR (S=8)

TP/TRM-LE/CA/BV-14-C [Carrier frequency offset and drift, LE Coded (S = 8)]	Lower limit	Upper limit	Measured	Unit	Status				
TP/TRM-LE/CA/BV-14-C [Carrier frequency offset and drift, LE Coded (S = 8)] @ Payload length: 37, Statistic Count: 10									
tblContinuation_10_1									
Channel 0									
tblContinuation_10_2									
Frequency Accuracy	-150.00	150.00	-25.51	kHz	Passed				
Frequency Drift	-50.00	50.00	-2.66	kHz	Passed				
Maximum Drift Rate	-19.20	19.20	-2.59	kHz/50 μs	Passed				
Frequency Offset	-150.00	150.00	-26.71	kHz	Passed				
Channel 19									
tblContinuation_10_3									
Frequency Accuracy	-150.00	150.00	-25.92	kHz	Passed				
Frequency Drift	-50.00	50.00	-3.04	kHz	Passed				
Maximum Drift Rate	-19.20	19.20	-2.71	kHz/50 μs	Passed				
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Table 24. Carrier frequency offset and drift at LR (S=8)...continued

TP/TRM-LE/CA/BV-14-C [Carrier frequency offset and drift, LE Coded (S = 8)]	Lower limit	Upper limit Measured		Unit	Status		
TP/TRM-LE/CA/BV-14-C [Carrier frequency offset and drift, LE Coded (S = 8)] @ Payload length: 37, Statistic Count: 10							
Frequency Offset	-150.00	150.00	-27.24	kHz	Passed		
Channel 39							
tblContinuation_10_4							
Frequency Accuracy	-150.00	150.00	-26.35	kHz	Passed		
Frequency Drift	-50.00	50.00	-3.00	kHz	Passed		
Maximum Drift Rate	-19.20	19.20	-3.00	kHz/50 µs	Passed		
Frequency Offset	-150.00	150.00	-27.66	kHz	Passed		

Conclusion:

Good margins, in line with the expected results.

3.3.2 RX tests

3.3.2.1 Test set up - Bluetooth LE



Figure 43. Conducted RX test setup for sensitivity with RF generator and faraday box





3.3.2.2 Sensitivity

3.3.2.2.1 With the ARB generator

Flashed software: Connectivity test

Test method:

• To remain immune to the external parasitic signals, put the K32W148 EVK into an RF shielded box.



Bluetooth LE:

The generator (Agilent NX5181 MXG) is used in the ARB mode to generate a pattern of 1500 packets. The TERATERM window is used to control the module.

- Four modes are checked: 1 Msps, 2 Msps, LR (S=2), and LR (S=8).
- Set it to channel 0.
- The connection is automatically established and the Packet Error Rate (PER) is measured.
- Decrease the level of the SFU at the RF input of the module until PER = 30.8 %.
- Repeat it up to channel 39.

Bluetooth LE results (@SMA connector):

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• The best sensitivity is on channel 9: -98.1 dBm

- The lowest sensitivity is on channel 31: -97.4 dBm
- Delta over channels: 0.7 dB

K32W148 EVK shows an average value of -97.7 dBm (1 Msps) at SMA connector.







• The best sensitivity is on channel 39: -95.9 dBm

- The lowest sensitivity is on channel 27: -95.2 dBm
- Delta over channels: 0.7 dB

K32W148 EVK shows an average value of -94.7 dBm (2 Msps) at SMA connector.



Figure 51. Sensitivity bathtub result – 2 Msps





• The best sensitivity is on channel 31: -101.9 dBm

- The lowest sensitivity is on channel 13: -101.0 dBm
- Delta over channels: 0.9 dB

K32W148 EVK shows an average value of -101.5 dBm (500 ksps) at SMA connector.



Figure 53. Sensitivity bathtub result – 500 ksps



Figure 54. Sensitivity result – LR (S = 8)

- The best sensitivity is on channel 11: -105.9 dBm
- The lowest sensitivity is on channel 28: -105.2 dBm
- Delta over channels: 0.7 dB

K32W148 EVK shows an average value of -105.6 dBm (125 ksps) at SMA connector.





Conclusion:

K32W148 EVK withstands an average sensitivity level of:

- -97.7 dBm @1 Msps (Data sheet typical value: -97.65 dBm at the SMA connector)
- -94.7 dBm @2 Msps (Data sheet typical value: -94.65 dBm at the SMA connector)

- -101.5 dBm @LRS2 (Data sheet typical value: -101.65 dBm at the SMA connector)
- -105.6 dBm @LRS8 (Data sheet typical value: -105.65 dBm at the SMA connector)

Note: To get the value at RF pin output (data sheet value), add 0.35 dB loss to the sensitivity results.

3.3.2.3 Receiver maximum input level

3.3.2.3.1 Bluetooth LE

Flashed software: HCI_BB

Test method:

- The same test setup as with the sensitivity test is used.
- The signal level is increased up to the PER = 30.8 % with 1500 packets.

Results:

Table 25. Maximum input power – 1 Msps

TP/RCV-LE/CA/BV-06-C [Maximum input signal level at 1 Ms/s]	Lower limit	Upper limit	Measured	Unit	Status		
TP/RCV-LE/CA/BV-06-C [Maximum input signal level at 1 Ms/s] @ Payload length: 37, No. of Packets: 1500, RF Level: 0 dBm							
Channel 0							
tblContinuation_7_1							
PER	-	30.8	16.66667	%	Passed		
Correct Packets	-	-	1250		Passed		
Channel 19							
tblContinuation_7_2							
PER	_	30.8	16.53333	%	Passed		
Correct Packets	_	_	1252		Passed		
Channel 39							
tblContinuation_7_3							
PER	_	30.8	14.73333	%	Passed		
Correct Packets	-	-	1279		Passed		

Table 26. Maximum input power – 2 Msps

TP/RCV-LE/CA/BV-12-C [Maximum input signal level at 2 Ms/s]	Lower limit	Upper limit	Measured	Unit	Status			
TP/RCV-LE/CA/BV-12-C [Maximum input signal level at 2 Ms/s] @ Payload length: 37, No. of Packets: 1500, RF Level: 0 dBm								
Channel 0								
tblContinuation_13_1								
PER	-	30.8	12.80000	%	Passed			
Correct Packets	-	_	1308		Passed			

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Table 26. Maximum input power – 2 Mspscontinued								
TP/RCV-LE/CA/BV-12-C [Maximum input signal level at 2 Ms/s]	Lower limit	Upper limit	Measured	Unit	Status			
TP/RCV-LE/CA/BV-12-C [Maximum input signal level at 2 Ms/s] @ Payload length: 37, No. of Packets: 1500, RF Level: 0 dBm								
Channel 19								
tblContinuation_13_2								
PER	-	30.8	10.53333	%	Passed			
Correct Packets	-	-	1342		Passed			
Channel 39								
tblContinuation_13_3								
PER	-	30.8	12.86667	%	Passed			
Correct Packets	_	_	1307		Passed			

Conclusion:

The results are limited by the maximum output power of the equipment.

3.3.2.4 RX spurious

Flashed software: Connectivity test

Test method:

- Set the radio to:
- Receiver mode, frequency: channel 18
- Set the analyzer to:
 - Ref amp = 20 dBm, Trace = max hold, detector = max peak
- Set Start/stop frequency: 30 MHz/1 GHz
 - RBW = 100 kHz, VBW = 300 kHz
- Then set the start/stop frequency: 1 GHz/30 GHz
 - RBW = 1 MHz, VBW = 3 MHz

Bluetooth LE results:



Conclusion:

• There are no spurs above the spectrum analyzer noise floor, except for 2xLO.

• More than -18 dB margin

3.3.2.5 Interferer results in Bluetooth

3.3.2.5.1 Receiver interference rejection performances

3.3.2.5.1.1 Adjacent, Alternate, and Co-channel rejection – Bluetooth LE @1 Msps, @2 Msps, @500 ksps (LR S=2), @125 ksps (LR S=8)

The interferers are at the adjacent channel (+/-1 MHz, +/-2 MHz, +/-3 MHz) or co-channel.

The test is performed with only one interfering unmodulated signal at a time.

Test method:

- Generator for the desired signal: Agilent N5182A
- Generator for interferers: R&S SFU
- Criterion: PER < 30.8 % with 1500 packets
- The expected signal is set to -67 dBm; the interferer is increased until the PER threshold is reached

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• Channels under test: 2, 19, and 37

Bluetooth LE @ 1 Msps:

Results









Good margin, in line with the expected results.

Bluetooth LE @ 2 Msps:

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Results



Figure 61. Adjacent, alternate, and co-channel rejection Bluetooth LE @2 Msps





Conclusion:

Good margin, in line with the expected results.

Bluetooth LE @500 ksps (LR S = 2):

Results:





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Figure 68. Adjacent, alternate, and co-channel rejection Bluetooth LE @500 ksps (LR S = 2) channel 37

Conclusion:

Good margin, in line with the expected results

Bluetooth LE @125 ksps (LR S = 8):

Results:







Good margin, in line with the expected results

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3.3.2.5.2 Receiver blocking

The blocking interferers are at the out-of-band channels depending on the receiver category.

3.3.2.5.2.1 Receiver category 1 - Bluetooth LE 1 Msps (Refer to the 300.328 2.1.1 chapter 4.3.1.12.4.2)

The test is performed with only one interfering signal at a time.

Flashed software: Connectivity test

Test method:

- Generator for the desired signal (Bluetooth LE 1 Msps): Agilent N5182A
- Generator for interferers: R&S SFU
- Criterion: PER < 10 %
- The expected signal is set to P_{min} + 6 dB (-82 dBm). The interferer is increased until the PER threshold is reached.
- Channels under test: 0 and 39

Result:



Figure 73. Receiver blocking (out of band) rejection - Bluetooth LE 1 Msps

Conclusion:

Good margin, in line with the expected results.

3.3.2.5.2.2 Receiver category 2 - Bluetooth LE 1 Msps (Refer to the 300.328 2.1.1 chapter 4.3.1.12.4.3)

The test is performed with only one interfering signal at a time.

Flashed software: Connectivity test

Test method:

- Generator for the desired signal (Bluetooth LE 1 Msps): Agilent N5182A
- Generator for interferers: R&S SFU
- Criterion: PER < 10 %
- The expected signal is set to P_{min} + 6 dB (-82 dBm). The interferer is increased until the PER threshold is reached.
- Channels under test: 0 and 39

Result:

	ch0	ch0	ch39	ch39
	2402	2402	2480	2480
	Low	High	Low	High
×	2380	2503.5	2380	2503.5
Interferer level (dBm)	-16.1	-18.1	-17.1	-19.1
300 328 limit (dBm)	-57	-57	-57	-57
Margin (dB)	40.9	38.9	39.9	37.9
	ch0	ch0	ch39	ch39
	2402	2402	2480	2480
	Low	High	Low	High
<u></u>	2300	2583.5	2300	2583.5
Interferer level (dBm)	-16.1	-17.1	-16.1	-17.6
300 328 limit (dBm)	-47	-47	-47	-47
Margin (dB)	30.9	29.9	30.9	29.4

Figure 74. Receiver blocking (out of band) rejection - Bluetooth LE 1 Msps

Conclusion:

Good margin, in line with the expected results.

3.3.2.5.2.3 Receiver category 1 - Bluetooth LE 2 Msps (Refer to the 300.328 2.1.1 chapter 4.3.1.12.4.2)

The test is performed with only one interfering signal at a time.

Flashed software: Connectivity test

Test method:

- Generator for the desired signal (Bluetooth LE 2 Msps): Agilent N5182A
- Generator for interferers: R&S SFU
- Criterion: PER < 10 %
- The expected signal is set to P_{min} + 6 dB (-82 dBm). The interferer is increased until the PER threshold is reached.
- Channels under test: 0 and 39

Result:

Interferer level (dBm)	ch0 2402 Low 2380 -16.1	ch0 2402 High 2503.5 -14.6	ch39 2480 Low 2380 -15.6	ch39 2480 High 2503.5 -16.6			
300 328 limit (dBm)	-53	-53	-53	-53			
Margin (db)	30.9	38.4	37.4	30.4			
Interferer level (dBm)	ch0 2402 Low 2300 -14.1	ch0 2402 Low 2330 -13.6	ch0 2402 Low 2360 -15.6	ch39 2490 Low 2300 -14.1	ch39 2480 Low 2330 -14.6	ch39 2480 Low 2380 -15.6	
Margin (dB)	32.9	33.4	31.4	32.9	32.4	31.4	
	ch0 2402 High 2523.5	ch0 2402 High 2553.5	ch0 2402 High 2583.5	ch0 2402 High 2813.5	ch0 2402 High 2643.5	ch0 2402 High 2673.5	
Interferer level (dBm)	-15.6	-13.6	-21.1	-13.6	-13.6	-13.6	
300 328 limit (dBm) Margin (dB)	-47 31.4	-47 33.4	-47 25.9	-47 33.4	-47 33.4	-47 33.4	
	ch39 2480 High 2523.5	ch 39 2480 High 2553.5	ch39 2480 High 2583.5	ch39 2480 High 2613.5	ch39 2480 High 2643.5	ch39 2480 High 2673.5	
Interferer level (dBm)	-15.6	-14.6	-15.6	-14.6	-14.6	-14.6	
300 328 limit (dBm) Margin (dB)	-47	-47	-47	-47	- 47	-47	
margin (db)	91.4	32.7	51.4	32.7	32.4	32.4	
Figure 75. Receiver blocking (out of band) rejection - Bluetooth LE 2 Msps							

Conclusion:

Good margin, in line with the expected results.

3.3.2.5.2.4 Receiver category 2 - Bluetooth LE 2 Msps (Refer to the 300.328 2.1.1 chapter 4.3.1.12.4.3)

The test is performed with only one interfering signal at a time.

Flashed software: Connectivity test

Test method:

- Generator for the desired signal (Bluetooth LE 2 Msps): Agilent N5182A
- Generator for interferers: R&S SFU
- Criterion: PER < 10 %
- The expected signal is set to P_{min} + 6 dB (-82 dBm). The interferer is increased until the PER threshold is reached.
- Channels under test: 0 and 39

Result:



Figure 76. Receiver blocking (out of band) rejection - Bluetooth LE 2 Msps

Conclusion:

Good margin, in line with the expected results.

3.3.2.5.2.5 Receiver category 1 - Bluetooth LE 500 ksps (LR S = 2) (Refer to the 300.328 2.1.1 chapter 4.3.1.12.4.2)

The test is performed with only one interfering signal at a time.

Flashed software: Connectivity test

Test method:

- Generator for the desired signal (Bluetooth LE 500 ksps [LR S = 2]): Agilent N5182A
- Generator for interferers: R&S SFU
- Criterion: PER < 10 %
- The expected signal is set to P_{min} + 6 dB (-82 dBm). The interferer is increased until the PER threshold is reached.
- Channels under test: 0 and 39

Result:


Conclusion:

Good margin, in line with the expected results.

3.3.2.5.2.6 Receiver category 2 - Bluetooth LE 500 ksps (LR S = 2) (Refer to the 300.328 2.1.1 chapter 4.3.1.12.4.3)

The test is performed with only one interfering signal at a time.

Flashed software: Connectivity test

Test method:

- Generator for the desired signal (Bluetooth LE 500 ksps [LR S = 2]): Agilent N5182A
- Generator for interferers: R&S SFU
- Criterion: PER < 10 %
- The expected signal is set to P_{min} + 6 dB (-82 dBm). The interferer is increased until the PER threshold is reached.
- Channels under test: 0 and 39

	ch0	ch0	ch39	ch39
	2402	2402	2480	2480
	Low	Low	High	High
	2380	2503.5	2380	2503.5
Interferer level (dBm)	-21.1	-19.6	-21.1	-21.6
300 328 limit (dBm)	-57	-57	-57	-57
Margin (dB)	35.9	37.4	35.9	35.4
	ch0	ch0	ch39	ch39
	2402	2402	2480	2480
	Low	Low	High	High
	2300	2583.5	2300	2583.5
Interferer level (dBm)	-18.6	-19.1	-21.1	-21.1
300 328 limit (dBm)	-47	-47	-47	-47
			05.0	05.0

Figure 78. Receiver blocking (out of band) rejection - Bluetooth LE 500 ksps [LR S = 2]

Conclusion:

Good margin, in line with the expected results.

3.3.2.5.2.7 Receiver category 1 - Bluetooth LE 125 ksps (LR S = 8) (Refer to the 300.328 2.1.1 chapter 4.3.1.12.4.2)

The test is performed with only one interfering signal at a time.

Flashed software: Connectivity test

Test method:

- Generator for the desired signal (Bluetooth LE 125 ksps [LR S = 8]): Agilent N5182A
- Generator for interferers: R&S SFU
- Criterion: PER < 10 %
- The expected signal is set to P_{min} + 6 dB (-82 dBm). The interferer is increased until the PER threshold is reached.
- Channels under test: 0 and 39



Conclusion:

Good margin, in line with the expected results.

3.3.2.5.2.8 Receiver category 2 - Bluetooth LE 125 ksps (LR S = 8) (Refer to the 300.328 2.1.1 chapter 4.3.1.12.4.3)

The test is performed with only one interfering signal at a time.

Flashed software: Connectivity test

Test method:

- Generator for the desired signal (Bluetooth LE 125 ksps [LR S = 8]): Agilent N5182A
- Generator for interferers: R&S SFU
- Criterion: PER < 10 %
- The expected signal is set to P_{min} + 6 dB (-82 dBm). The interferer is increased until the PER threshold is reached.
- Channels under test: 0 and 39

Interferer level (dBm) 802.15.4 limit (dBm) Margin (dB)	ch0 2402 Low 2380 -21.1 -57 35.9	ch0 2402 Low 2503.5 -19.1 -57 37.9	ch39 2480 High 2380 -31.1 -57 25.9	ch39 2480 High 2503.5 -31.1 -57 25.9
Interferer level (dBm) 802.15.4 limit (dBm) Margin (dB)	ch0 2402 Low 2300 -19.6 -47 27.4	ch0 2402 Low 2583.5 -19.1 -47 27.9	ch39 2480 High 2300 -31.1 -47 15.9	ch39 2480 High 2583.5 -31.1 -47 15.9

Figure 80. Receiver blocking (out of band) rejection - Bluetooth LE 125 ksps [LR S = 8]

Conclusion:

Good margin, in line with the expected results.

3.3.2.5.3 Blocking interferers

3.3.2.5.3.1 Bluetooth LE 1 Msps

To verify that the receiver performs satisfactorily with frequency outside the 2400 MHz-2483.5 MHz, a CW is used as the interferer source.

Flashed software: Connectivity test

Test method:

- Generator for the desired signal (Bluetooth LE 1 Msps): Agilent N5182A
- Generator for the blocker: R&S SFU
- Criterion: PER < 30.8 % with 1500 packets
- The expected signal is set to -67 dBm. The interferer level is increased until the PER threshold is reached.
- Channel under test: 12 (2426 MHz)

Result:

Tuble 21. Blocking in					
Expected	ch12	ch12	ch12	ch12	
signal 2426 MHz @-67 dBm 24	2426 MHz	2426 MHz	2426 MHz	2426 MHz	
Interferer (MHz)	30 - 2000 (step 10 MHz)	2003 – 2399 (step 3 MHz)	2484 – 2997 (step 3 MHz)	3 GHz - 12.75 GHz (step 25 MHz)	
Unexpected level (dBm)	-30	-35	-35	-30	
Status (unexpected level)	PASS	PASS	PASS	PASS	
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Table 27. Blocking interferers – 1 Msps

	I				
Expected	ch12	ch12	ch12	ch12	
signal 2426 MHz @-67 dBm	2426 MHz	2426 MHz	2426 MHz	2426 MHz	
Number of blocking fail	0	0	0	0	Failed blockers must not exceed 10
Status (UnW level -50 dBm)	PASS	PASS	PASS	PASS	
Number of blocking fail	0	0	0	0	Failed blockers must not exceed 3

Table 27. Blocking interferers – 1 Msps...continued

Conclusion:

• Good margin, in line with the expected results.

3.3.2.5.3.2 Bluetooth LE 2 Msps

To verify that the receiver performs satisfactorily with frequency outside the 2400 MHz-2483.5 MHz, a CW is used as the interferer source.

Flashed software: Connectivity test

Test method:

- Generator for the desired signal (Bluetooth LE 2 Msps): Agilent N5182A
- Generator for the blocker: R&S SFU
- Criterion: PER < 30.8 % with 1500 packets
- The expected signal is set to -67 dBm. The interferer level is increased until the PER threshold is reached.
- Channel under test: 12 (2426 MHz)

Result:

 Table 28. Blocking interferers – 2 Msps

Expected	ch12	ch12	ch12	ch12	
signal 2426 MHz @-67 dBm	2426 MHz	2426 MHz	2426 MHz	2426 MHz	
Interferer (MHz)	30 - 2000 (step 10 MHz)	2003 – 2399 (step 3 MHz)	2484 – 2997 (step 3 MHz)	3 GHz - 12.75 GHz (step 25 MHz)	
Unexpected level (dBm)	-30	-35	-35	-30	
Status (unexpected level)	PASS	PASS	PASS	PASS	
Number of blocking fail	0	0	0	0	Failed blockers must not exceed 10
Status (UnW level -50 dBm)	PASS	PASS	PASS	PASS	
Number of blocking fail	0	0	0	0	Failed blockers must not exceed 3

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Conclusion:

• Good margin, in line with the expected results.

3.3.2.5.3.3 Bluetooth LE 500 ksps (LR S = 2)

To verify that the receiver performs satisfactorily with frequency outside the 2400 MHz-2483.5 MHz, a CW is used as the interferer source.

Flashed software: Connectivity test

Test method:

- Generator for the desired signal (Bluetooth LE 500 ksps (LR S = 2)): Agilent N5182A
- Generator for the blocker: R&S SFU
- Criterion: PER < 30.8 % with 1500 packets
- The expected signal is set to -67 dBm. The interferer level is increased until the PER threshold is reached.
- Channel under test: 12 (2426 MHz)

Result:

 Table 29. Blocking interferers – 500 ksps

Expected	ch12	ch12	ch12	ch12	
signal 2426 MHz @-67 dBm	2426 MHz	2426 MHz	2426 MHz	2426 MHz	
Interferer (MHz)	30 - 2000 (step 10 MHz)	2003 – 2399 (step 3 MHz)	2484 – 2997 (step 3 MHz)	3 GHz - 12.75 GHz (step 25 MHz)	
Unexpected level (dBm)	-30	-35	-35	-30	
Status (unexpected level)	PASS	PASS	PASS	PASS	
Number of blocking fail	0	0	0	0	Failed blockers must not exceed 10
Status (UnW level -50 dBm)	PASS	PASS	PASS	PASS	
Number of blocking fail	0	0	0	0	Failed blockers must not exceed 3

Conclusion:

· Good margin, in line with the expected results.

3.3.2.5.3.4 Bluetooth LE 125 ksps (LR S = 8)

To verify that the receiver performs satisfactorily with frequency outside the 2400 MHz-2483.5 MHz, a CW is used as the interferer source.

Flashed software: Connectivity test

Test method:

- Generator for the desired signal (Bluetooth LE 125 ksps (LR S = 8)): Agilent N5182A
- Generator for the blocker: R&S SFU

- Criterion: PER < 30.8 % with 1500 packets
- The expected signal is set to -67 dBm. The interferer level is increased until the PER threshold is reached.
- Channel under test: 12 (2426 MHz)

Result:

Table 30. Blocking interferers – 125 ksps

Expected	ch12	ch12	ch12	ch12	
signal 2426 MHz @-67 dBm	2426 MHz	2426 MHz	2426 MHz	2426 MHz	
Interferer (MHz)	30 - 2000 (step 10 MHz)	2003 – 2399 (step 3 MHz)	2484 – 2997 (step 3 MHz)	3 GHz - 12.75 GHz (step 25 MHz)	
Unexpected level (dBm)	-30	-35	-35	-30	
Status (unexpected level)	PASS	PASS	PASS	PASS	
Number of blocking fail	0	0	0	0	Failed blockers must not exceed 10
Status (UnW level -50 dBm)	PASS	PASS	PASS	PASS	
Number of blocking fail	0	0	0	0	Failed blockers must not exceed 3

Conclusion:

• Good margin, in line with the expected results.

3.3.2.5.4 Intermodulation

This test verifies that the receiver intermodulation performance is satisfactory.

Two interferers are used in combination with the expected signal: a sinusoid non-modulated signal and a modulated signal with PRSB15 data.

3.3.2.5.4.1 Bluetooth LE 1 Msps

Flashed software: Connectivity test

Test method:

- Generator for the desired signal (Bluetooth LE 1 Msps): Agilent N5182A
- Generator for the first interferer (CW): R&S SML03
- Generator for the second interferer (PRBS15): R and S SFU
- Criterion: PER < 30.8 % with 1500 packets
- The expected signal is set to -67 dBm; the interferer levels are set to the data sheet specification values.
- Channels under test: 0, 19, and 39.

Results:

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	ch0	ch0	ch0	ch0	ch0	ch0
	2402	2402	2402	2402	2402	2402
	Low	Low	Low	Low	Low	Low
Interferer1 (CW) (MHz)	-5	-4	-3	3	4	5
Interferer2 (Mod) (MHz)	-10	-8	-6	6	8	10
Interferer level (dBm)	-21.6	-21.6	-22.6	-22.6	-22.6	-23.1
Datasheet limit (dBm)	-24	-23	-23	-23	-23	-24
Margin (dB)	14.5	13.5	12.5	12.5	12.5	13.0
	ch19	ch19	ch19	ch19	ch19	ch19
	2440	2440	2440	2440	2440	2440
	Mid	Mid	Mid	Mid	Mid	Mid
Interferer1 (CW) (MHz)	-5	-4	-3	3	4	5
Interferer2 (Mod) (MHz)	-10	-8	-6	6	8	10
Interferer level (dBm)	-22.6	-22.6	-22.6	-22.6	-22.6	-23.1
Datasheet limit (dBm)	-24	-23	-23	-23	-23	-24
Margin (dB)	13.5	12.5	12.5	12.5	12.5	13.0
	ch39	ch39	ch39	ch39	ch39	ch39
	2480	2480	2480	2480	2480	2480
	High	High	High	High	High	High
Interferer1 (CW) (MHz)	-5	-4	-3	3	4	5
Interferer2 (Mod) (MHz)	-10	-8	-6	6	8	10
Interferer level (dBm)	-23.1	-22.6	-23.1	-23.6	-23.1	-23.6
Datasheet limit (dBm)	-24	-23	-23	-23	-23	-24
Margin (dB)	13.0	12.5	12.0	11.5	12.0	12.5

Figure 81. Intermodulation – 1 Msps

Conclusion:

Good margin, in line with the expected results.

3.3.2.5.4.2 Bluetooth LE 2 Msps

Flashed software: Connectivity test

Test method:

- Generator for the desired signal (Bluetooth LE 2 Msps): Agilent N5182A
- Generator for the first interferer (CW): R&S SML03
- Generator for the second interferer (PRBS15): R and S SFU
- Criterion: PER < 30.8 % with 1500 packets
- The expected signal is set to -64 dBm; the interferer levels are set to the data sheet specification values.
- Channels under test: 0, 19, and 39.

	-					
	ch0	ch0	ch0	ch0	ch0	ch0
	2402	2402	2402	2402	2402	2402
	Low	Low	Low	Low	Low	Low
Interferer1 (CW) (MHz)	-10	-8	-6	6	8	10
Interferer2 (Mod) (MHz)	-20	-16	-12	6	8	10
Interferer level (dBm)	-20.6	-20.6	-21.6	-21.6	-23.6	-24.1
Datasheet limit (dBm)	-24	-23	-23	-23	-23	-24
Margin (dB)	15.5	14.5	13.5	13.5	11.5	12.0
	ch19	ch19	ch19	ch19	ch19	ch19
	2440	2440	2440	2440	2440	2440
	Mid	Mid	Mid	Mid	Mid	Mid
Interferer1 (CW) (MHz)	-10	-8	-6	6	8	10
Interferer2 (Mod) (MHz)	-20	-16	-12	6	8	10
Interferer level (dBm)	-23.6	-23.6	-23.6	-23.6	-23.6	-24.1
Datasheet limit (dBm)	-24	-23	-23	-23	-23	-24
Margin (dB)	12.5	11.5	11.5	11.5	11.5	12.0
	ch39	ch39	ch39	ch39	ch39	ch39
	2480	2480	2480	2480	2480	2480
	High	High	High	High	High	High
Interferer1 (CW) (MHz)	-10	-8	-6	6	8	10
Interferer2 (Mod) (MHz)	-20	-16	-12	6	8	10
Interferer level (dBm)	-24.1	-23.6	-24.1	-24.6	-24.1	-24.6
Datasheet limit (dBm)	-24	-23	-23	-23	-23	-24
Margin (dB)	12.0	11.5	11.0	10.5	11.0	11.5

Figure 82. Intermodulation – 2 Msps

Conclusion:

Good margin, in line with the expected results.

4 802.15.4 application

4.1 Test presentation

4.1.1 List of tests

- 1. Conducted tests
 - a. TX tests
 - i. Frequency accuracy
 - ii. Phase noise
 - iii. TX power
 - iv. TX spurious
 - v. Harmonics
 - vi. EVM and offset EVM

- vii. Upper band edge
- b. RX tests
 - i. Sensitivity
 - ii. Sensitivity bathtub
 - iii. Maximum Input Level
 - iv. RX spurious
 - v. LO leakage
 - vi. Interferers (as per 802.15.4 requirements)
 - vii. Co-channel
 - viii. Receiver Blocking (as per ETSI 300 328 requirements)

4.2 Test summary

<u>Table 31</u> and <u>Table 32</u> synthesize the main tests performed on the K32W148 modules. This document details most of the test results. To get further information, contact your NXP local contact.

Table 31	. List	of tests	(Europe)
			· · · · · /

		Reference	Limit	Status
	TX maximum power	ETSI EN 300 328	20 dBm, 100 mW (radiated)	PASS
	Eirp TX spectral density	ETSI EN 300 328	10 dBm/MHz	PASS
-	TX spectral density	802.15.4_2011	-20 dBc or -30 dBm (100 kHz, f-fc > 3.5 MHz)	PASS
	Spurious 30 MHz – 1 GHz	ETSI EN 300 328	-36 dBm or -54 dBm (depends on frequency) (100 kHz BW)	PASS
Iransmission	Spurious 1 GHz - 12.5 GHz	ETSI EN 300 328	-30 dBm (1 MHz BW)	PASS
-	EVM	802.15.4_2011	35 %	PASS
-	TX frequency tolerance	802.15.4_2011	+/- 40 ppm	PASS
-	Reachable low limit of maximum power	802.15.4_2011	-3 dBm	PASS
	Phase noise (unspread)	802.15.4_2003	NA	For information
	RX emissions 30 MHz – 1 GHz	ETSI EN 300 328	-57 dBm (100 kHz)	PASS
Decention	RX emissions 1 GHz - 12.5 GHz	ETSI EN 300 328	-47 dBm (1 MHz)	PASS
Reception	RX sensitivity	802.15.4	-85 dBm	PASS
	Adjacent channel interference rejection N+/-1	802.15.4_2011	0 dB	PASS

Table 31.	List of tests	(Europe)continued
-----------	---------------	-------------------

			Reference	Limit	Status
		Alternate channel interference rejection N+/-2	802.15.4_2011	30 dB	PASS
		Receiver blocking	ETSI EN 300 328	-57 dBm/-47 dBm	PASS
		RX maximum input level	802.15.4_2011	-20 dBm	PASS
Miscellaneous		Return loss (S11)	Return loss in TX mode	For information	
			Return loss in RX mode	For information	

Table 32. List of tests (US)

			Reference	Limit	Status
Transmission	Spurious 1 GHz - 12.5 GHz	Spurious 1 GHz - 12.5	ECC part15	-41 dBm	PASS
			(1 MHz BW)	FA00	

4.3 Conducted tests

4.3.1 TX tests

4.3.1.1 Test setup

The TX power of the K32W148 is set to +10 dBm.

Connect the RF port of the module to the spectrum analyzer via RF cable.



4.3.1.2 Frequency accuracy

Test method:

- Set the radio to:
 - TX mode
 - CW
 - Continuous mode
 - Frequency: Channel 18
- Set the analyzer to:
 - Center frequency = 2.44 GHz
 - Span = 1 MHz
 - Ref amp = 20 dBm
 - RBW = 10 kHz
- Measure the CW frequency with the marker of the spectrum analyzer.

Result:



Figure 84. Frequency accuracy

- Measured frequency: 2440.0014 MHz
- ppm value = 0.57 ppm

Table 33. Frequency accuracy

Result	Target	802.15.4 limit		
0.57 ppm	+/-25 ppm	+/-40 ppm		

Note: The frequency accuracy depends on the XTAL model. The model used on the EVK is NX2016SA EXS00A-CS11775 from NDK. And set the XtalTrim to **15**.

Conclusion:

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• The channel frequency is correctly centered therefore fully compliant with the 802.15.4 specifications.

4.3.1.3 Phase noise @ 100 kHz offset

Test method:

- Set the radio to:
 - TX mode
 - CW
 - Continuous mode
 - Frequency: Channel 18
- Set the analyzer to:
 - Center frequency = 2.44 GHz
 - Span = 1 MHz
 - Ref amp = 20 dBm
- Measure the phase noise at 100 kHz offset frequency.
- **–** RBW = 10 kHz (40 dBc)



Figure 85. Phase noise

Result:

- Marker value = 41.1 dBm within 10 kHz RBW
 - **–** Marker delta = 10.0 (-41.1) = 51.1 dB
 - Phase noise at 100 kHz offset = 51.1-10 Log (10 kHz) = 91.1 dBc/Hz

Conclusion:

Phase noise is for information only.

4.3.1.4 TX power (fundamental)

Test method:

- Set the radio to:
 - TX mode
 - Modulated
 - Continuous mode
- Set the analyzer to:
 - Start frequency = 2.4 GHz
 - Stop frequency = 2.5 GHz
 - Ref amp = 20 dBm
 - Sweep time = 100 ms
 - **–** RBW = 3 MHz
 - Max Hold mode
 - Detector: Peak
- Sweep all the channels from ch11 to ch26.



Result:

- Maximum power is on channel 26: +10.08 dBm.
- Minimum power is on channel 11: **+9.96 dBm**.
- Tilt over frequencies is **0.1 dB**.

Conclusion:

• The power is flat over frequency.

4.3.1.5 TX power in-band

Test method:

- Set the radio to:
 - TX mode
 - Modulated
 - Continuous mode
 - Data rate (1 Msps, 2 Msps, 500 ksps, 125 ksps)
- · Set the analyzer to:
 - Start freq = 2.35 GHz
 - Stop freq = 2.5 GHz
 - Ref amp = 10 dBm
 - Sweep time = 100 ms
 - RBW = 100 kHz
 - Video BW = 300 kHz
 - Max Hold mode
 - Detector = RMS
 - Number of Sweeps = 10
- Sweep on Channel 11, Channel 18, and Channel 26.



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Application note

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Figure 88. TX power in-band – Channel 19

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Figure 89. TX power in-band – Channel 26

Conclusion:

• These results are compliant to 802.15.4.

4.3.1.6 TX spurious



4.3.1.6.1 Global view from 0.3 GHz to 12.5 GHz (expected = channel 18)

Conclusion:

- There are no TX spurs above the EN 300 328 limit. It is 16 dB margin.
- Harmonics are measured in the following paragraphs.

4.3.1.6.2 H2 (ETSI test conditions)

Test method:

- Set the radio to:
 - TX mode
 - Modulated
 - Continuous mode
- Set analyzer to:
 - Start frequency = 4.8 GHz
 - Stop frequency = 5 GHz
 - Ref amp = -20 dBm
 - Sweep time = 100 ms
 - **–** RBW = 1 MHz
 - Max hold mode
 - Detector peak
- Sweep all the channels from Ch11 to Ch26.

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Results:



Figure 91. Conducted H2 spurious

Maximum power is on channel 11: -45.3 dBm.

Conclusion:

• There is 15.3 dB margin to ETSI limit.

4.3.1.6.3 H3 (ETSI test conditions)

Test method:

The test method is similar as for the H2, except that the spectrum analyzer frequency start/stop are set to 7.2 GHz and 7.5 GHz.





Figure 92. Conducted H3 spurious

Maximum power is on channel 19: -55.3 dBm.

Conclusion:

• There is 25.3 dB margin to ETSI limit.

4.3.1.6.4 H4 (ETSI test conditions)

Test method:

The test method is similar as for the H2, except that the spectrum analyzer frequency span is set from 9.6 GHz to 10.0 GHz.

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Figure 93. Conducted H4 spurious

Maximum power is on channel 16: -42.3 dBm.

Conclusion:

• There is **12.3 dB** margin to ETSI limit.

4.3.1.6.5 H5 (ETSI test conditions)

Test method:

The test method is similar as for the H2, except that the spectrum analyzer frequency start/stop are set to 12.0 GHz to 12.5 GHz.

Results:



Figure 94. Conducted H5 spurious

Maximum power is on channel 16: **-59 dBm**.

Conclusion:

• There is 29 dB margin to ETSI limit.

4.3.1.6.6 H6 to H10 (ETSI test conditions)

Test method:

The test method is similar as for the H2, except that the spectrum analyzer frequency span is set to corresponding frequency range.

 Table 34.
 Conducted H6 to H10 spurious

	H6	H7	H8	Н9	H10
EN limit	-30	-30	-30	-30	-30
Spurious Power	-48.6	-55.6	-55.2	-48.3	-47.3
Margin	18.6	25.6	25.2	18.3	17.3

















Conclusion:

• There is good margin to the ETSI limit.

4.3.1.6.7 H2 (FCC test conditions)

Test method:

- Set the radio to:
 - TX mode
 - Modulated
 - Continuous mode
- Set analyzer to:
 - Start frequency = 4.8 GHz
 - Stop frequency = 5 GHz
 - Ref amp = -20 dBm
 - RF attenuation = sweep time = 100 ms
 - **–** RBW = 1 MHz

- Trace mode: Average
- Detector RMS
- Sweep all the channels from ch11 to ch26.

Results:



Figure 100. Conducted H2 spurious

Maximum power is on channel 11: -43.5 dBm.

Conclusion:

• There is 2.5 dB margin to FCC limit.

4.3.1.6.8 H3 (FCC test conditions)

Test method:

The test method is similar as for the H2, except that the spectrum analyzer frequency start/stop are set to 7.2 GHz and 7.5 GHz.



Figure 101. Conducted H3 spurious

Maximum power is on channel 18 to 26: -58 dBm.

Conclusion:

• There is 17 dB margin to FCC limit.

4.3.1.6.9 H4 (FCC test conditions)

Test method:

The test method is similar as for the H2, except that the spectrum analyzer frequency span is set from 9.6 GHz to 10.0 GHz.

Results:



Figure 102. Conducted H4 spurious

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Maximum power is on channel 17: **-46 dBm**.

Conclusion:

• There is **5 dB** margin to FCC limit.

4.3.1.6.10 H5 (FCC test conditions)

Test method:

The test method is similar as for the H2, except that the spectrum analyzer frequency span is set from 12 GHz to 12.5 GHz.

Results:



Maximum power is on channel 17: -63 dBm.

Conclusion:

• There is 22 dB margin to FCC limit.

4.3.1.6.11 H6 to h10 (FCC test conditions)

Test method:

The test method is similar as for the H2, except that the spectrum analyzer frequency span is set to corresponding frequency range.

	H6	H7	H8	H9	H10	
FCC limit	-41.5	-41.5	-41.5	-41.5	-41.5	
Spurious Power	-59.5	-63.2	-62.9	-57.4	-58.3	
Margin	18	21.7	21.4	15.9	16.8	

Table 35. Conducted H6 to H10 spurious

Results:

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Figure 108. Conducted H10 spurious

Conclusion:

• There is **good** margin to the FCC limit on H6, H7, H8, H9, and H10.

4.3.1.7 TX modulation

4.3.1.7.1 EVM

Test method:

- Connect the RF port of the module to the R&S FSV spectrum analyzer. To do the EVM measurement, use the specific menu of the SA.
- Set the K45W in continuous modulated mode.
- Set the TX frequency to Channel 11.
- Measure the offset EVM value.
- Repeat the test for each channel.

Figure 109 shows the EVM test result.



Maximum value is on channel 23 = 7.0 %.

Conclusion:

• Very good margin.

4.3.1.7.2 Offset EVM

Test method:

Similar method as for the EVM measurement

Result:



Maximum value is on channel 23 = 0.38 %.

Conclusion:
• Very good margin vs 802.15.4 limit.

4.3.1.8 Lower band edge – MIIT China

Test method:

- Set the radio to:
 - TX mode
 - Modulated
 - Burst mode
- Set the Channel 11 (2.405 GHz)
- Set analyzer to:
 - Start freq = 2.385 GHz
 - Stop freq = 2.415 GHz
 - Ref amp = -20 dBm
 - Sweep time = 100 ms
 - Sweep point: 8001 pts
 - **–** RBW = 1 MHz
 - Video BW = 3 MHz
 - Detector = RMS MaxHold

Results:

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Figure 111. Lower band edge – Channel 11

Conclusion:

- The lower band edge test passes the Bluetooth SIG (MIIT-China) certification.
- There is good margin to MIIT-China) limit (-50 dBm below 2.39 GHz).

4.3.1.9 Upper band edge – MIIT China

Test method:

- Set the radio to:
 - TX mode
 - Modulated
 - Continuous mode
 - Maximum RF output power +10 dBm (not passing the FCC requirement)
 - Set the channel 26 (2.48 GHz).
 - Set the power -5 dBm for 802.15.4.
- Set analyzer to:
 - Start freq = 2.477 GHz
 - Stop freq = 2.507 GHz
 - Ref amp = -20 dBm
 - Sweep time = 40 ms

- Sweep point: 8001 pts
- **–** RBW = 1 MHz
- Video BW = 3 MHz
- Detector = RMS, Max Hold

Results:

Spectrum Spectr	um 2 🗷 Vs	SA 🗶			
Ref Level 20.00 dBm	e RBV	N/1 MHz			
Att 40 dB 👄 S	WT 100 ms 👄 VBV	🖌 3 MHz	Mode Auto Sweep		
Count 88/100					
●1Rm Max					
			M2[1]		-41.92 dBm
					2.4835000 GHz
10 dBm			M1[1]		-7.15 dBm
				1 1	2.4800090 GHZ
0 dBm					
	M1				
-10 dBm	-				
-20 dBm					
20 0011					
0.0 40-					
-30 dBm					
		M2			
-40 dBm	, 	Y			
~-50-d8m					
-60 dBm					
-70 dBm					
Start 2.47 GHz	•	691	pts		Stop 2.5 GHz

Figure 112. Bluetooth LE - Upper band edge – Channel 26

Conclusion:

• The upper band edge test passes the Bluetooth SIG (MIIT-China) certification in TX power have to set down to -5 dBm from +10 dBm on ch26.

4.3.1.10 Upper band edge (FCC ANSI C63.10, 558074 D01 DTS)

Test method:

- Set the radio to:
 - TX mode
 - Modulated
 - Continuous mode
 - Maximum RF output power +10 dBm (does not pass the FCC requirement)

- Set the RF output power +5 dBm.
- Set analyzer to:
 - Start freq = 2.475 GHz
 - Stop freq = 2.485 GHz
 - Ref amp = -20 dBm
 - Sweep time = 100 ms
 - RBW = 100 kHz
 - Video BW = 300 kHz
 - Detector = Average
 - Average mode: power
 - Number of Sweeps = 100
 - Set Channel 26 (2.48 GHz)
 - Trace mode: Max hold

Results:



Figure 113. Upper band edge – Channel 39

Modulation	TX power +5 dBm
Level @2.4835 GHz	-42 dBm

FCC limit: < -41.15 dBm

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Conclusion:

 The upper band edge test passes the FCC certification (<41.15dBm@2.4835GHz) in TX power have to set down to +5 dBm from +10 dBm on ch26.

4.3.1.11 Out of band (ETSI 300 328 chapter 5.4.8.2.1)

Test method:

- Set the radio to:
 - TX mode
 - Modulated
 - Continuous mode
- Set analyzer to:
 - Start freq = 2.375 GHz
 - Stop freq = 2.510 GHz
 - Ref amp = -20 dBm
 - Sweep time = 100 ms
 - RBW = 1 MHz
 - Video BW = 3 MHz
 - Detector = Average
 - Average mode: Power
 - Number of Sweeps = 100
 - Set Channel 0 (2.402 GHz) and 39 (2.48 GHz)
 - Trace mode: Max hold

Results:



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Conclusion:

• The out of band test passes the ETSI certification.

4.3.1.12 Out of band (ARIB STD T-66)

Test method:

- Set the radio to:
 - TX mode
 - Modulated
 - Continuous mode
- Set analyzer to:
 - Start freq = 2.475 GHz
 - Stop freq = 2.485 GHz
 - Ref amp = -20 dBm
 - Sweep time = 100 ms
 - **–** RBW = 1 MHz
 - Video BW = 1 MHz
 - Detector = Peak
 - Average mode: Power
 - Number of Sweeps = 100
 - Set Channel 0 (2.402 GHz) and 39 (2.48 GHz)
 - Trace mode: Max hold

Results:

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Conclusion:

• The out of band test passes the ARIB STD T-66 certification.

4.3.2 RX tests

4.3.2.1 Test setup







Figure 119. Conducted RX test setup for spurious



Figure 120. Conducted RX test setup for interference rejection

4.3.2.2 RX sensitivity

Test method:

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To avoid any interference, place the carrier board and K32W148 module in an RF shield room.

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Generator: Keysight N5182B

The generator is used in ARB mode. It generates a pattern of 1000 packets of 20 octets. The DIO19 of the K32W148 is connected to the trigger input of the generator.

A TERATERM window is used to control the module.

- · Set the receive frequency to Channel 11.
- Set the module in Trigger packet test.
- The connection is automatically established and the Packet Error Rate (PER) is measured.
- Decrease the level of the generator at the RF input of the module until PER = 1 %.
- Do the same for other channels.

Results:



Conclusion:

• Minimum value: - 103.1 dBm on channel 12

• Maximum value: -102.8 dBm on channel 23

Note:

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In RX test, K32W148 is not able to receive all packages when set interval time < 1.6 ms between two packets. Through our calculation, in below and 832 μ s is OK.

All frames are 20 bytes = 40 bytes + 12 symbols for PHY header = 52 symbols.

Time delta between two 20 bytes frames is $832 \ \mu s = 52$ symbols.

Time delta = SFD2 - SFD1 = [4 bytes preamble, 1 byte SFD] of frame2 + [IFS] + [length + PHY payload] of frame 1 = 10 symbols + IFS + 42 symbols = 52 symbols + IFS => IFS = 0

4.3.2.3 RX sensitivity bathtub

Test method:

To avoid any interference, place the carrier board and K32W148 module in an RF shield room.

Generator: Keysight N5182B

The generator is used in ARB mode. It generates a pattern of 1000 packets of 20 octets. The DIO19 of the K32W148 is connected to the trigger input of the generator.

A TERATERM window is used to control the module.

- Set the receive frequency to Channel 11.
- Set the module in Trigger packet test.
- The connection is automatically established and the PER is measured.
- Decrease the level of the generator at the RF input of the module until PER = 1 %.

Results:



4.3.2.4 Receiver maximum input level

Test method:

Generator: Keysight N5182B

The generator is used in ARB mode. It generates a pattern of 1000 packets of 20 octets. The DIO19 of the K32W148 is connected to the trigger input of the generator.

A TERATERM window is used to control the module.

- Set the receive frequency to channel 11.
- Set the module in Trigger packet test.
- The connection is automatically established and the PER is measured.
- Decrease the level of the generator at the RF input of the module until PER = 1 %.

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• Do the same for other channels.

Results:



Conclusion:

The actual maximum input level cannot be measured with the test environment. The maximum level that can be delivered to the K32W148 is limited by the maximum output power of the generator.

The maximum input level of K32W148 is higher than **20 dBm** on all channels.

4.3.2.5 RX spurious

Test method:

- Set the radio to:
 - Receiver mode
 - Frequency: Channel 18
- · Set the analyzer to:
 - Ref amp = 20 dBm
 - Trace = max hold
 - Detector = max peak
 - Start/stop frequency: 30 MHz/1 GHz
 - RBW = 100 kHz
 - Start/stop frequency: 1 GHz/12.75 GHz
 - **–** RBW = 1 MHz

Results:



Note: No spurious has been detected.

4.3.2.6 Receiver interference rejection

4.3.2.6.1 Adjacent and alternate channels with standard interferers

Interferers are located in the adjacent channel (n-1 and n+1) or alternate channels (n-2 and n+2).

The test is performed with only one interfering signal at a time.

Test method:

Generator for desired signal: Keysight N5182B generator (modulated)

Generator for interferers: Keysight E8267D (modulated)

Criterion: PER < 1 %

The expected signal is set to - 82 dBm. The interferer is increased until the PER threshold has been reached.

Channels under test: 11, 18, and 26 (although n-1, n-2 are not system relevant for channel 11 and n+, n+2 are not system relevant for channel 26).

Results:

Table 36. Adjacent and alternate rejection	on
--	----

			-									
		24	05		2440			2480				
	n-2	n-1	n+1	n+2	n-2	n-1	n+1	n+2	n-2	n-1	n+1	n+2
	2395	2400	2410	2415	2430	2435	2445	2450	2470	2475	2485	2490
interfere (dBm)	-35	-45	-45	-36	-36	-45	-45	-35	-36	-45	-45	-36
Interfere (dBc)	47	37	37	46	46	37	37	47	46	37	37	46

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Table 36. Adjacent and alternate rejection...continued

802.15.4 limit	30	0	0	30	30	0	0	30	30	0	0	30
Margin	17	37	37	16	16	37	37	17	16	37	37	16

Conclusion:

Good margin, in line with the expected results.

4.3.2.6.2 N-3 and n+3 channels with standard interferers

Test method:

Similar as for the adjacent and alternate channels but the interferer is set at +/- 15 MHz offset from the desired channel.

Results:

Table 37. N-/+3 band rejection

	24	05	24	40	2480		
	n-3	n+3	n-3	n+3	n-3	n+3	
	2400	2405	2425	2455	2465	2495	
Interfere (dBm)	-31	-31	-31	-31	-31	-31	
Interfere (dBc)	51	51	51	51	51	51	

Conclusion:

In line with expected values.

4.3.2.6.3 Co-channel

Results:

Table 38. Co-channel

	2405	2440	2480
expected	-82	-82	-82
interfere (dBm)	-85	-86	-85
interfere (dBm)	-3	-4	-3

Table 39. Co-channel with worst case

	2405	2440	2480
expected (sensi + 3 dB)	-100	-100	-100
interfere (dBm)	-104	-104	-103
interfere (dBm)	-4	-4	-3

Conclusion:

In line with expected values.

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4.3.2.7 Receiver blocking

The K32W148 is the equipment of category 1 as defined by the ETSI 300 328 (TX signal higher than 10 dBm). Tests and limits are used according to category 1.

Interferer is a CW signal.

4.3.2.7.1 Test 1

Results:

	ch11	ch11	ch26	ch26
	2405	2405	2480	2480
	Low	High	Low	High
	2380	2504	2380	2504
interferer level(dBm)	3.7	5.8	5.5	3.3
interferer level(dBc)	72.9	75	74.7	72.5
802.15.4 limit(dBm)	-34	-34	-34	-34
Margin(dB)	37.7	39.8	39.5	37.3

Figure 125. Receiver blocking test 1

Conclusion:

Very good margin.

4.3.2.7.2 Test 2

Results:

	ch11	ch11	ch11	ch26	ch26	ch26
	2405	2405	2405	2480	2480	2480
	Low	Low	Low	Low	Low	Low
	2300	2330	2360	2300	2330	2360
interferer level(dBm)	0.2	-0.5	0.5	0	0	-0.2
interferer level(dBc)	79	78	77	79	77	78
802.15.4 limit(dBm)	-34	-34	-34	-34	-34	-34
Margin(dB)	34.2	33.5	34.5	34	34	33.8

Figure 126. Receiver blocking test 2

Conclusion:

Very good margin.

4.3.2.7.3 Test 3

Results:

	ch11	ch11	ch11	ch11	ch11	ch11
	2405	2405	2405	2405	2405	2405
	High	High	High	High	High	High
	2524	2554	2584	2614	2644	2674
interferer level(dBm)	0.3	0.3	0.7	1	0.8	1
interferer level(dBc)	77	77	78	78	78	78
802.15.4 limit(dBm)	-34	-34	-34	-34	-34	-34
Margin(dB)	34.3	34.3	34.7	35	34.8	35

	ch26	ch26	ch26	ch26	ch26	ch26
	2480	2480	2480	2480	2480	2480
	High	High	High	High	High	High
	2524	2554	2584	2614	2644	2674
interferer level(dBm)	-0.7	0	0.1	0.5	0.5	0.6
interferer level(dBc)	76	77	77	77	77	77
802.15.4 limit(dBm)	-34	-34	-34	-34	-34	-34
Margin(dB)	33.3	34	34.1	34.5	34.5	34.6

Figure 127. Receiver blocking test 3

Conclusion:

Very good margin.

5 Return loss

5.1 RF path with matching components using VDD_PA_2G4 pin.

Measurements are done using the SMA connector. Therefore, the C4 capacitor is mounted and the C3 capacitor is not mounted.



Matching components are:

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Reference	Value	Description	Mfr. name	Mfr. part number
L2	15 nH	IND 0.015 µH @ 100 MHz 450 mA +/-5% 0402	MURATA	LQG15HZ15NJ02D
L3	0 ohm	Resistor shunt	_	—
L15	1.5 nH	IND 0.0015 µH @ 100 MHz 1000 mA +/-0.1 nH 0402	MURATA	LQG15WH1N5B02

· Capacitors

Reference	Value	Description	Mfr. name	Mfr. part number
C2	2.5 pF	CAP CER 2.5 pF 50 V 0.1 pF C0G 0402	MURATA	GCM1555C1 H2R5BA16
C1	1.1 pF	CAP CER 1.1 pF 50 V 0.1 pF C0G 0402	MURATA	GCM1555C1 H1R1BA16
C10	12 pF	CAP CER 12 pF 50 V 5 % C0G AEC-Q200 0402	MURATA	GCM1555C1 H120JA16D
C9	1 µF	CAP CER 1 µF 10 V 10 % X7S AEC-Q200 0402	MURATA	GCM155C71 A105KE38D

Note: C3 value populated on the X-K32W1-EVK is 15 pF. To improve the IFA antenna matching, the preferred value is 1.5 pF.

5.2 RX

In the RC mode, the return loss measurement is performed by setting the LNA gain of K32W148 to the maximum.

Hardware: X-K32W148-EVK



Results:

• Return loss: -12.8 dB (2.48 GHz) < S11 < -8.7 dB (2.4 GHz)

There is no specification for the return loss.

Conclusion:

• The return loss (S11) is lower than -8 dB.

5.3 TX

In the TX mode, the return loss measurement is performed by setting the K32W148 RF output power to the minimum.

Hardware: K32W148 EVK



Results:

• Return loss: -12.5 dBm (2.4 GHz) < S11 < -9.3 dB (2.48 GHz)

There is no specification for the return loss.

Conclusion:

• The return loss (S11) is lower than -9 dB.

5.4 RF line insertion loss

To extract RF line insertion loss, we have cut the board and solder SMA on Pin ANT_2P4GHZ to isolate the RF line. Remove default component matching and replace by 0 Ω resistor.

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Insertion losses =
$$\frac{1}{1-|s_11|^2} X |s_12|^2$$

Thanks to Equation 1, we can quantify insertion losses and mismatch losses.

 $Mismatch \ losses = -10 \ x \log(1 - \Gamma ? 2)$

 $\Gamma = = 10^{-15.3/20} = 0.171791$

Mismatch losses = -10log (1- 0.171791?2) = -0.13 dB

Insertion losses = Global losses - Mismatch losses

Insertion losses = -0.38 - (-0.13)

Insertion losses = -0.25 dB

In additional to insertion line losses, we should add SMD insertion losses estimate at 0.1 dB.

6 Conclusion

Beyond the RED, FCC, Bluetooth LE 5.0, and 802.15.4 compliance, these radio tests prove a good performance of the K32W1 wireless MCUs.

7 Connectivity test tool settings

This application note presents the connectivity test tools settings for the tests.

• For test in transmit modes:

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Putty COM58 - Putty	-		×
			^
**** ****** ***** ***** ***** ***** ***** ***** ***** ****** ***** ****** ****** ****** ****** ******* ******* ******** ************************************			
•••• • ••••• •			
Connectivity Test Demo			
-Press enter to start			
			~
COM58-PuTTY	-		×
-Press It1 for Ty operation			
-Press [r] for fx operation -Press [g] for channel up			
-Press [w] for channel down -Press [a] for Power up			
-Press [s] for Power down -Press [d] to increase the XTAL Trim value			
-Press [f] to decrease the XTAL Trim value -Press [n] to increase the Payload			
-Press [m] to decrease the Payload -Press [k] to increase CCA Threshold in Carrier Sense Test			
-Press [1] to decrease CCA Threshold in Carrier Sense Test -Press [2] to toggle Acknoledgement(None/Ack/EnhAck)			
-Press [x] to change the source address for the packets -Press [c] to change the destination address for the packets			
These keys can be used all over the application to change the test parameters			
Select the Test to perform			
-Press [1] continuous tests			v
Putty COM58 - Putty	-		×
[z] toggle Ack for Tx (None/Ack/EnhAck)		_	~
<pre>[z] toggle Ack for Tx (None/Ack/EnhAck) [x] change the source address [c] change the destination address</pre>			^
<pre>[7] toggle Ack for Tx (None/Ack/BnhAck) [x] change the source address [c] change the destination address</pre>			^
<pre>[2] toggle Ack for Tx (None/Ack/BnhAck) [x] change the source address [c] change the destination address [c] continuous Test Menu]</pre>			^
<pre>[2] toggle Ack for Tx (None/Ack/BnhAck) [x] change the source address [] change the destination address [] Continuous Test Menu]</pre>			^
<pre>[2] toggle Ack for Tx (None/Ack/BhhAck) [x] change the source address [] change the destination address [] Continuous Test Menu []</pre>			^
<pre>[2] toggle Ack for Tx (None/Ack/BhAck) [x] change the source address [c] change the destination address</pre>			^
<pre>[2] toggle Ack for Tx (None/Ack/BhAck) [x] change the source address [c] change the destination address</pre>			^
<pre>[2] toggle Ack for Tx (None/Ack/BhAck) [X] change the source address [C] change the destination address [C] change the destination address [C] continuous Test Menu [C] [C] [C] [C] [C] [C] [C] [C] [C] [C]</pre>			^
<pre>[2] toggle Ack for Tx (None/Ack/BhAck) [x] change the source address [c] change the destination address [] [] Continuous Test Menu]</pre>			^
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<pre>[2] toggle Ack for Tx (None/Ack/BhAck) [X] change the source address [C] change the destination address [C] change the destination address [C] continuous Test Menu [C] Press [1] Idle Press [2] Burst PRBS Transmission using packet mode Press [3] Continuous Modulated Transmission Press [4] Continuous Reception Press [5] Continuous Reception Press [6] Continuous Secan Press [6] Continuous Cca Press [7] Frevious Menu Now Running: Continuous Tx Modulated - FN9 Mode Tx, Channel 11, Power 5, Payload 20, CCA Thresh -&00dEm, Xt Press [5] for Fower down</pre>	alTrim 0		~ ~
<pre>[2] toggle Ack for Tx (None/Ack/BhAck) [X] change the source address [C] change the destination address [C] change the destination address [C] continuous Test Menu [</pre>	alTrim O	>	× ×
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Section 3.3.1.2	1) 4)
Section 4.3.1.3	1) 4)
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Section 3.3.1.6	1) 3) 2)
Section 4.3.1.7	1) 3) 2)
Section 4.3.1.7.1	1) 3) 2
Section 4.3.1.7.2	1) 4)
Section 3.3.1.8	1) 3) ch26
Tx return loss	1) 3) 2)

• For PER test:



AN13728

K32W1 RF System Evaluation Report for Bluetooth Low Energy and 802.15.4 Applications

COM58 - PuTTY	- 0	×
-Press [s] for Fower down -Press [d] to increase the XTAL Trim value -Press [f] to decrease the XTAL Trim value -Press [n] to increase the Payload -Press [k] to increase CCA Threshold in Carrier Sense Test -Press [k] to decrease CCA Threshold in Carrier Sense Test -Press [z] to toggle Acknoledgement (Non-Kak/EnhAck) -Press [z] to toggle Acknoledgement (Non-Kak/EnhAck) -Press [z] to change the source address for the packets These keys can be used all over the application to change the test parameters		^
Select the Test to perform -Press [1] Continuous tests -Press [2] Packet Error Rate test -Press [3] Range test -Press [4] Carrier Sense and Transmission Control menu -Press [5] Trigger Packet test -Press [1] Reset MCU		
Mode Rx, Channel 11, Power 5, Pavload 20, CCA Thresh -80dBm, X	(talTrim 0 >	\sim
روم COM58 - PuTTY	- 0	×
COM58 - PuTTY PER Test Rx Running	- 0	×
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COMS8-PuTTY PER Test Rx Running PER Test Finished Received 59 of 1000 packets transmitted Press [enter] to go back to the Per Rx test menu		×
COMSS-PuTTY PER Test Rx Running PER Test Finished Received 59 of 1000 packets transmitted Press [enter] to go back to the Per Rx test menu	- 0	× ^

Chapter	CMET selection
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Section 4.3.2.4	5) bar)+/-
Section 4.3.2.5	5) bar)
Section 4.3.2.6	5) bar)+/-
Section 4.3.2.7	5) bar)+/-
Section 5.2	

A signal generator sends packets to the K32W148 device.

Then, packets received by K32W148 are counted about 6 seconds and the test is done.

Packets received out to sent packets is calculated and displayed.

8 References

- FCC: 47 CFR Part 15C
- RED: European Radio Equipment Directive applied from June 2016
- R&TTE: Radio and Telecommunications Terminal Equipment Directive (R&TTED) (1999/5/EC) was stopped on June 2016

- ETSI EN 300 328 v2.2.2: European Telecommunication Standard Radio Equipment and Systems (RES) Wideband data transmission systems, Technical characteristics, and test conditions for data transmission equipment operating in the 2.4 GHz ISM band and using spread spectrum modulation techniques
- IEEE 802.15.4: IEEE standard for Information technology Telecommunications and information exchange between systems – Local and metropolitan area networks – Specific requirements – Part 15.4: Wireless Medium Access Control (MAC) and Physical Layer (PHY) Specifications for Low Rate Wireless Personnel Area Networks (LR-WPANs)
- ETS EN 300 328: European Telecommunication Standard—Radio Equipment and Systems (RES) Wideband data transmission systems, Technical characteristics, and test conditions for data transmission equipment operating in the 2.4-GHz ISM band and using spread spectrum modulation techniques.
- RF-PHY TS 4.2.0/5.0: Bluetooth Test Specification. This document defines test structures and procedures for qualification testing of Bluetooth implementations of the Bluetooth Low Energy RF PHY.
- FCC Part 15: Operation to FCC Part 15 is subject to two conditions.
 - The device may not cause harmful interference.
 - The device must accept any interference received, including interference that may cause undesired operation.

Hence, there is no guaranteed quality of service when operating a Part 15 device.

9 Revision history

Rev.	Date	Description
0	5 September 2022	Initial release
1	27 March 2023	Removed the KW45-related description

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